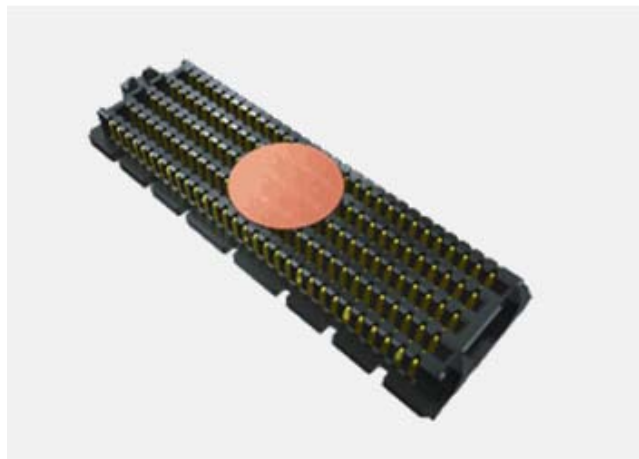




Project Number: Design Qualification Test Report	Tracking Code: 317173_Report_Rev_2
Requested by: Catie Eichhorn	Date: 12/18/2015
Part #: SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A- K-TR	
Part description: SEAF/SEAM	Tech: Peter Chen
Test Start: 05/10/2014	Test Completed: 06/16/2014



DESIGN QUALIFICATION TEST REPORT

SEAF/SEAM

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

Tracking Code: 317173 Report Rev 2

Part #: SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

Part description: SEAF/SEAM

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
07/30/2014	1	Initial Issue	PC
12/18/2015	2	Add the 14 rows test data.	KH

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR and DWV/IR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR and DWV/IR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead free
- 9) Samtec Test PCBs used: PCB-106294-TST-XX, PCB-106295-TST-XX, PCB-106296-TST-XX.

FLOWCHARTS**Gas Tight**Group 1

SEAF-50-05.0-L-10-2-A-K-TR

SEAM-50-02.0-L-10-2-A-K-TR

8 Assemblies

Step Description

1. LLCR μ ₁
Max Delta = 15 mOhm
2. Gas Tight μ ₁
3. LLCR μ ₁
Max Delta = 15 mOhm

(1) Gas Tight = EIA-364-36

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max
 Test Current = 100 mA Max

Normal ForceGroup 1

SEAF-50-05.0-L-10-2-A-K-TR

SEAM-50-02.0-L-10-2-A-K-TR

8 Contacts Minimum

Signal Without Thermals

Step Description

1. Contact Gaps
2. Normal Force μ ₁
Deflection = 0.012 "
Expected Force at Max Deflection = 80 g

Group 2

SEAF-50-05.0-L-10-2-A-K-TR

SEAM-50-02.0-L-10-2-A-K-TR

8 Contacts Minimum

Signal With Thermals

Step Description

1. Contact Gaps
2. Thermal Age μ ₁
3. Contact Gaps
4. Normal Force μ ₁
Deflection = 0.012 "
Expected Force at Max Deflection = 80 g

(1) Normal Force = EIA-364-04

(2) Thermal Age = EIA-364-17

Test Condition = 4 (105°C)
 Time Condition = 8 (250 Hours)

FLOWCHARTS Continued**Thermal Aging**Group 1

SEAF-50-05.0-L-10-2-A-K-TR

SEAM-50-02.0-L-10-2-A-K-TR

8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force μ_1
3.	LLCR μ_1 Max Delta = 15 mOhm
4.	Thermal Age μ_1
5.	LLCR μ_1 Max Delta = 15 mOhm
6.	Mating/Unmating Force μ_1
7.	Contact Gaps

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17

Test Condition = 4 (105°C)

Time Condition = B (250 Hours)

FLOWCHARTS Continued

Mating/Unmating/DurabilityGroup 1

SEAF-50-05.0-L-10-2-A-K-TR
SEAM-50-02.0-L-10-2-A-K-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	LLCR μ_1 Max Delta = 15 mOhm
3.	Mating/Unmating Force μ_1
4.	Cycles Quantity = 25 Cycles
5.	Mating/Unmating Force μ_1
6.	Cycles Quantity = 25 Cycles
7.	Mating/Unmating Force μ_1
8.	Cycles Quantity = 25 Cycles
9.	Mating/Unmating Force μ_1
10.	Cycles Quantity = 25 Cycles
11.	Mating/Unmating Force μ_1
12.	Contact Gaps
13.	LLCR μ_1 Max Delta = 15 mOhm
14.	Thermal Shock μ_1
15.	LLCR μ_1 Max Delta = 15 mOhm
16.	Humidity μ_1
17.	LLCR μ_1 Max Delta = 15 mOhm
18.	Mating/Unmating Force μ_1

Group 2

SEAF-30-05.0-L-08-2-A-K-TR
SEAM-30-02.0-L-08-2-A-K-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force μ_1
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force μ_1
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force μ_1
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force μ_1
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force μ_1

Group 3

SEAF-10-05.0-L-04-2-A-K-TR
SEAM-10-02.0-L-04-2-A-K-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force μ_1
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force μ_1
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force μ_1
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force μ_1
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force μ_1

- (1) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max
- (3) Mating/Unmating Force = EIA-364-13
- (4) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued

Mating/Unmating/DurabilityGroup 1

SEAM-40-03.5-S-14-2-A-K

SEAF-40-06.5-S-14-2-A-K

8 Assemblies

Step	Description
1.	Contact Gaps
2.	LLCR ⁽²⁾
3.	Mating/Unmating Force ⁽³⁾
4.	Cycles Quantity = 25 Cycles
5.	Mating/Unmating Force ⁽³⁾
6.	Cycles Quantity = 25 Cycles
7.	Mating/Unmating Force ⁽³⁾
8.	Cycles Quantity = 25 Cycles
9.	Mating/Unmating Force ⁽³⁾
10.	Cycles Quantity = 25 Cycles
11.	Mating/Unmating Force ⁽³⁾
12.	Contact Gaps
13.	LLCR ⁽²⁾ Max Delta = 15 mOhm
14.	Thermal Shock ⁽⁴⁾
15.	LLCR ⁽²⁾ Max Delta = 15 mOhm
16.	Humidity ⁽¹⁾
17.	LLCR ⁽²⁾ Max Delta = 15 mOhm
18.	Mating/Unmating Force ⁽³⁾

(1) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(3) Mating/Unmating Force = EIA-364-13

(4) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued

IR/DWV**Pin-to-Pin**

<u>Group 1</u>		<u>Group 2</u>		<u>Group 3</u>		<u>Group 4</u>	
SEAF-50-05.0-L-10-2-A-K-TR SEAM-50-02.0-L-10-2-A-K-TR 2 Assemblies		SEAF-50-05.0-L-10-2-A-K-TR 2 Assemblies		SEAM-50-02.0-L-10-2-A-K-TR 2 Assemblies		SEAF-50-05.0-L-10-2-A-K-TR SEAM-50-02.0-L-10-2-A-K-TR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown ₍₁₎	1.	DWV Breakdown ₍₁₎	1.	DWV Breakdown ₍₁₎	1.	IR ₍₁₎
						2.	DWV at Test Voltage ₍₁₎
						3.	Thermal Shock ₍₁₎
						4.	IR ₍₁₎
						5.	DWV at Test Voltage ₍₁₎
						6.	Humidity ₍₁₎
						7.	IR ₍₁₎
						8.	DWV at Test Voltage ₍₁₎

Row-to-Row

<u>Group 5</u>		<u>Group 6</u>		<u>Group 7</u>		<u>Group 8</u>	
SEAF-50-05.0-L-10-2-A-K-TR SEAM-50-02.0-L-10-2-A-K-TR 2 Assemblies		SEAF-50-05.0-L-10-2-A-K-TR 2 Assemblies		SEAM-50-02.0-L-10-2-A-K-TR 2 Assemblies		SEAF-50-05.0-L-10-2-A-K-TR SEAM-50-02.0-L-10-2-A-K-TR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown ₍₁₎	1.	DWV Breakdown ₍₁₎	1.	DWV Breakdown ₍₁₎	1.	IR ₍₁₎
						2.	DWV at Test Voltage ₍₁₎
						3.	Thermal Shock ₍₁₎
						4.	IR ₍₁₎
						5.	DWV at Test Voltage ₍₁₎
						6.	Humidity ₍₁₎
						7.	IR ₍₁₎
						8.	DWV at Test Voltage ₍₁₎

- (1) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (2) DWV Breakdown = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (3) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (4) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max
- (5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**Current Carrying Capacity**Group 1

SEAF-50-05.0-L-10-2-A-K-TR
SEAM-50-02.0-L-10-2-A-K-TR
10 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 1

Group 2

SEAF-50-05.0-L-10-2-A-K-TR
SEAM-50-02.0-L-10-2-A-K-TR
20 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 2

Group 3

SEAF-50-05.0-L-10-2-A-K-TR
SEAM-50-02.0-L-10-2-A-K-TR
30 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 3

Group 4

SEAF-50-05.0-L-10-2-A-K-TR
SEAM-50-02.0-L-10-2-A-K-TR
40 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 4

Group 5

SEAF-50-05.0-L-10-2-A-K-TR
SEAM-50-02.0-L-10-2-A-K-TR
500 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 50

(1) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

Current Carrying CapacityGroup 1

SEAM-40-03.5-S-14-2-A-K
SEAF-40-06.5-S-14-2-A-K
14 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 14
Number of Positions = 1

Group 2

SEAM-40-03.5-S-14-2-A-K
SEAF-40-06.5-S-14-2-A-K
28 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 14
Number of Positions = 2

Group 3

SEAM-40-03.5-S-14-2-A-K
SEAF-40-06.5-S-14-2-A-K
42 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 14
Number of Positions = 3

Group 4

SEAM-40-03.5-S-14-2-A-K
SEAF-40-06.5-S-14-2-A-K
56 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 14
Number of Positions = 4

Group 5

SEAM-40-03.5-S-14-2-A-K
SEAF-40-06.5-S-14-2-A-K
560 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 14
Number of Positions = 40

(1) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued

Mechanical Shock/Random Vibration/LLCRGroup 1

SEAF-50-05.0-L-10-2-A-K-TR

SEAM-50-02.0-L-10-2-A-K-TR

8 Assemblies

Step Description

1. LLCR μ_1
Max Delta = 15 mOhm
2. Mechanical Shock μ_1
3. Random Vibration μ_1
4. LLCR μ_1
Max Delta = 15 mOhm

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event DetectionGroup 1

SEAF-50-05.0-L-10-2-A-K-TR

SEAM-50-02.0-L-10-2-A-K-TR

60 Points

Step Description

1. Nanosecond Event Detection
(Mechanical Shock) μ_1
2. Nanosecond Event Detection
(Random Vibration) μ_1

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

FLOWCHARTS Continued**Mechanical Shock/Random Vibration/LLCR**Group 1

SEAM-40-03.5-S-14-2-A-K

SEAF-40-06.5-S-14-2-A-K

8 Assemblies

Step Description

1. LLCR ⁽¹⁾
2. Mechanical Shock ⁽²⁾
3. Random Vibration ⁽³⁾
4. LLCR ⁽¹⁾
Max Delta = 15 mOhm

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event DetectionGroup 1

SEAM-40-03.5-S-14-2-A-K

SEAF-40-06.5-S-14-2-A-K

60 Points

Step Description

1. Nanosecond Event Detection
(Mechanical Shock) ⁽¹⁾
2. Nanosecond Event Detection
(Random Vibration) ⁽²⁾

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

FLOWCHARTS Continued

Extended Life

Group 1
SEAF-50-05.0-S-10-2-A-K-TR
SEAM-50-02.0-S-10-2-A-K-TR
8 Assemblies
250 Cycles

Step	Description
1.	Plating Thickness Verification ⁽⁴⁾
2.	LLCR ⁽²⁾ Max Delta = 15 mOhm
3.	Cycles Quantity = 250 Cycles
4.	LLCR ⁽²⁾ Max Delta = 15 mOhm
5.	Thermal Shock ⁽⁵⁾
6.	LLCR ⁽²⁾ Max Delta = 15 mOhm
7.	Humidity ⁽¹⁾
8.	LLCR ⁽²⁾ Max Delta = 15 mOhm
9.	Photos ⁽³⁾

Group 2
SEAF-50-05.0-S-10-2-A-K-TR
SEAM-50-02.0-S-10-2-A-K-TR
8 Assemblies
500 Cycles

Step	Description
1.	Plating Thickness Verification ⁽⁴⁾
2.	LLCR ⁽²⁾ Max Delta = 15 mOhm
3.	Cycles Quantity = 500 Cycles
4.	LLCR ⁽²⁾ Max Delta = 15 mOhm
5.	Thermal Shock ⁽⁵⁾
6.	LLCR ⁽²⁾ Max Delta = 15 mOhm
7.	Humidity ⁽¹⁾
8.	LLCR ⁽²⁾ Max Delta = 15 mOhm
9.	Photos ⁽³⁾

Group 3
SEAF-50-05.0-S-10-2-A-K-TR
SEAM-50-02.0-S-10-2-A-K-TR
8 Assemblies
1000 Cycles

Step	Description
1.	Plating Thickness Verification ⁽⁴⁾
2.	LLCR ⁽²⁾ Max Delta = 15 mOhm
3.	Cycles Quantity = 1000 Cycles
4.	LLCR ⁽²⁾ Max Delta = 15 mOhm
5.	Thermal Shock ⁽⁵⁾
6.	LLCR ⁽²⁾ Max Delta = 15 mOhm
7.	Humidity ⁽¹⁾
8.	LLCR ⁽²⁾ Max Delta = 15 mOhm
9.	Photos ⁽³⁾

(1) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(3) Photos

Attach 2-3 photos of contact area

(4) Plating Thickness Verification

Measure, verify, and document plating thickness on both male and female (one group only)

Plating thickness to be measured on loose pins used during assembly

(5) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

THERMAL:

- 1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors*.
- 2) Test Condition 4 at 105° C
- 3) Test Time Condition B for 250 hours.
- 4) All test samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003” to 0.004” of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition C
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
- 2) Test Condition V, Letter B
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G ‘RMS’: 7.56
- 5) Frequency: 50 to 2000 Hz
- 6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at four temperature points are reported:
 - a. Ambient
 - b. 85° C
 - c. 95° C
 - d. 115° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure
- 4) Procedure:
 - a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
 - b. Test Conditions:
 - i. Class II--- Mated pairs of contacts assembled to their plastic housings.
 - ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
 - iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
 - iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
 - v. Exposure time, 55 to 65 minutes.
 - vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
 - vii. The samples shall be dried after exposure for a minimum of 1 hour.
 - viii. Drying temperature 50° C
 - ix. The final LLCR shall be conducted within 1 hour after drying.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

NORMAL FORCE (FOR CONTACTS TESTED IN THE HOUSING):

- 1) Reference document: EIA-364-04, *Normal Force Test Procedure for Electrical Connectors*.
- 2) The contacts shall be tested in the connector housing.
- 3) If necessary, a "window" shall be made in the connector body to allow a probe to engage and deflect the contact at the same attitude and distance (plus 0.05 mm [0.002"]) as would occur in actual use.
- 4) The connector housing shall be placed in a holding fixture that does not interfere with or otherwise influence the contact force or deflection.
- 5) Said holding fixture shall be mounted on a floating, adjustable, X-Y table on the base of the Dillon TC², computer controlled test stand with a deflection measurement system accuracy of 5.0 μm (0.0002").
- 6) The nominal deflection rate shall be 5 mm (0.2")/minute.
- 7) Unless otherwise noted a minimum of five contacts shall be tested.
- 8) The force/deflection characteristic to load and unload each contact shall be repeated five times.
- 9) The system shall utilize the TC² software in order to acquire and record the test data.
- 10) The permanent set of each contact shall be measured within the TC² software.
- 11) The acquired data shall be graphed with the deflection data on the X-axis and the force data on the Y-axis and a print out will be stored with the Tracking Code paperwork.
- 12) The acquired data shall be graphed with the deflection data on the X-axis and the force data on the Y-axis and a print out will be stored with the Tracking Code paperwork.

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 5000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs
- 2) MEASUREMENTS/CALCULATIONS
 - a. The breakdown voltage shall be measured and recorded.
 - b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
 - c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

RESULTS**Temperature Rise, CCC at a 20% de-rating****SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR**

- CCC for a 30°C Temperature Rise-----2.7 A per contact with 10 contacts (10x1) powered
- CCC for a 30°C Temperature Rise-----2.0 A per contact with 20 contacts (10x2) powered
- CCC for a 30°C Temperature Rise-----1.6 A per contact with 30 contacts (10x3) powered
- CCC for a 30°C Temperature Rise-----1.4 A per contact with 40 contacts (10x4) powered
- CCC for a 30°C Temperature Rise-----0.6 A per contact with 500 contacts (10x50) powered

SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K

- CCC for a 30°C Temperature Rise-----2.2 A per contact with 14 contacts (14x1) powered
- CCC for a 30°C Temperature Rise-----1.6 A per contact with 28 contacts (14x2) powered
- CCC for a 30°C Temperature Rise-----1.3 A per contact with 42 contacts (14x3) powered
- CCC for a 30°C Temperature Rise-----1.1 A per contact with 56 contacts (14x4) powered
- CCC for a 30°C Temperature Rise-----0.5 A per contact with 560 contacts (14x40) powered

Mating – Unmating Forces**Thermal Aging Group (SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR)**

- **Initial**
 - **Mating**
 - **Min**-----16.78 Lbs
 - **Max**-----23.33 Lbs
 - **Unmating**
 - **Min**----- 9.64 Lbs
 - **Max**-----13.11 Lbs
- **After Thermal**
 - **Mating**
 - **Min**-----13.69 Lbs
 - **Max**-----15.69 Lbs
 - **Unmating**
 - **Min**----- 8.66 Lbs
 - **Max**-----10.10 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating-Unmating Durability Group (SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR)**

- **Initial**
 - **Mating**
 - **Min** -----19.10 Lbs
 - **Max** -----21.73 Lbs
 - **Unmating**
 - **Min** -----9.76 Lbs
 - **Max** -----12.85 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** -----19.98 Lbs
 - **Max** -----22.78 Lbs
 - **Unmating**
 - **Min** -----11.09 Lbs
 - **Max** -----14.28 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** -----20.26 Lbs
 - **Max** -----24.11 Lbs
 - **Unmating**
 - **Min** -----12.30 Lbs
 - **Max** -----15.20 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** -----20.87 Lbs
 - **Max** -----24.25 Lbs
 - **Unmating**
 - **Min** -----13.06 Lbs
 - **Max** -----15.80 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** -----21.26 Lbs
 - **Max** -----25.10 Lbs
 - **Unmating**
 - **Min** -----13.67 Lbs
 - **Max** -----16.23 Lbs
- **Humidity**
 - **Mating**
 - **Min** -----14.99 Lbs
 - **Max** -----17.61 Lbs
 - **Unmating**
 - **Min** -----6.38Lbs
 - **Max** -----8.58 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating/Unmating Durability Group (SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K)**

- **Initial**
 - **Mating**
 - **Min**-----28.26 Lbs
 - **Max**-----35.79 Lbs
 - **Unmating**
 - **Min**-----19.65 Lbs
 - **Max**-----24.96 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min**-----29.83 Lbs
 - **Max**-----37.96 Lbs
 - **Unmating**
 - **Min**-----22.88 Lbs
 - **Max**-----28.74 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min**-----28.63 Lbs
 - **Max**-----36.10 Lbs
 - **Unmating**
 - **Min**-----23.09 Lbs
 - **Max**-----28.82 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min**-----29.01 Lbs
 - **Max**-----36.51 Lbs
 - **Unmating**
 - **Min**-----23.64 Lbs
 - **Max**-----29.92 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min**-----29.79 Lbs
 - **Max**-----37.83 Lbs
 - **Unmating**
 - **Min**-----23.74 Lbs
 - **Max**-----30.50 Lbs
- **After Humidity**
 - **Mating**
 - **Min**-----22.37 Lbs
 - **Max**-----29.11 Lbs
 - **Unmating**
 - **Min**-----11.30 Lbs
 - **Max**-----21.07 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating-Unmating Basic (SEAF-30-05.0-L-08-2-A-K-TR/ SEAM-30-02.0-L-08-2-A-K-TR)**

- **Initial**
 - **Mating**
 - **Min** -----12.54 Lbs
 - **Max** -----15.06 Lbs
 - **Unmating**
 - **Min** ----- 7.05 Lbs
 - **Max** ----- 9.39 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** -----14.37 Lbs
 - **Max** -----18.33 Lbs
 - **Unmating**
 - **Min** ----- 8.65 Lbs
 - **Max** -----10.54 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** -----14.03 Lbs
 - **Max** -----17.90 Lbs
 - **Unmating**
 - **Min** ----- 9.30 Lbs
 - **Max** -----11.29 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** -----14.04 Lbs
 - **Max** -----17.37 Lbs
 - **Unmating**
 - **Min** -----10.16 Lbs
 - **Max** -----12.16 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** -----14.23 Lbs
 - **Max** -----17.77 Lbs
 - **Unmating**
 - **Min** -----10.55 Lbs
 - **Max** -----12.63 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating-Unmating Basic (SEAF-10-05.0-L-04-2-A-K-TR/ SEAM-10-02.0-L-04-2-A-K-TR)**

- **Initial**
 - **Mating**
 - **Min** ----- 2.31 Lbs
 - **Max** ----- 2.72 Lbs
 - **Unmating**
 - **Min** ----- 1.14 Lbs
 - **Max** ----- 1.61 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 2.40 Lbs
 - **Max** ----- 3.06 Lbs
 - **Unmating**
 - **Min** ----- 1.35 Lbs
 - **Max** ----- 1.90 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 2.45 Lbs
 - **Max** ----- 3.17 Lbs
 - **Unmating**
 - **Min** ----- 1.32 Lbs
 - **Max** ----- 2.02 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 2.47 Lbs
 - **Max** ----- 3.35 Lbs
 - **Unmating**
 - **Min** ----- 1.32 Lbs
 - **Max** ----- 2.07 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 2.47 Lbs
 - **Max** ----- 3.45 Lbs
 - **Unmating**
 - **Min** ----- 1.30 Lbs
 - **Max** ----- 2.10 Lbs

Normal Force at 0.0112 inch deflection

- **Initial**
 - **Min** ----- 68.80 gf **Set** ---- 0.0007 in
 - **Max** ----- 76.50 gf **Set** ---- 0.0009 in
- **Thermal**
 - **Min** ----- 56.00 gf **Set** ---- 0.0014 in
 - **Max** ----- 69.10 gf **Set** ---- 0.0027 in

RESULTS Continued**Insulation Resistance minimums, IR****Pin to Pin**

- **Initial**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Thermal Shock**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Humidity**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed

Row to Row

- **Initial**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Thermal Shock**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- **Humidity**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
 - Breakdown Voltage----- 1000 VAC
 - Test Voltage ----- 750 VAC
 - Working Voltage ----- 250 VAC

Pin to Pin

- **Initial DWV**-----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

Row to Row

- **Initial DWV**-----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

RESULTS Continued**LLCR Thermal Aging Group (192 LLCR test points)**

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

- **Initial** -----7.87 mOhms Max
- **Thermal**
 - $\leq +5.0$ mOhms ----- 192 Points ----- Stable
 - $+5.1$ to $+10.0$ mOhms ----- 0 Points ----- Minor
 - $+10.1$ to $+15.0$ mOhms ----- 0 Points ----- Acceptable
 - $+15.1$ to $+50.0$ mOhms ----- 0 Points ----- Marginal
 - $+50.1$ to $+2000$ mOhms ----- 0 Points ----- Unstable
 - $>+2000$ mOhms ----- 0 Points ----- Open Failure

LLCR Gas Tight Group (192 LLCR test points)

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

- **Initial** -----8.28 mOhms Max
- **Gas-Tight**
 - $\leq +5.0$ mOhms ----- 192 Points ----- Stable
 - $+5.1$ to $+10.0$ mOhms ----- 0 Points ----- Minor
 - $+10.1$ to $+15.0$ mOhms ----- 0 Points ----- Acceptable
 - $+15.1$ to $+50.0$ mOhms ----- 0 Points ----- Marginal
 - $+50.1$ to $+2000$ mOhms ----- 0 Points ----- Unstable
 - $>+2000$ mOhms ----- 0 Points ----- Open Failure

LLCR Mating/Unmating Durability Group (192 LLCR test points)

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

- **Initial** -----7.70 mOhms Max
- **Durability, 100 Cycles**
 - $\leq +5.0$ mOhms ----- 192 Points ----- Stable
 - $+5.1$ to $+10.0$ mOhms ----- 0 Points ----- Minor
 - $+10.1$ to $+15.0$ mOhms ----- 0 Points ----- Acceptable
 - $+15.1$ to $+50.0$ mOhms ----- 0 Points ----- Marginal
 - $+50.1$ to $+2000$ mOhms ----- 0 Points ----- Unstable
 - $>+2000$ mOhms ----- 0 Points ----- Open Failure
- **Thermal Shock**
 - $\leq +5.0$ mOhms ----- 192 Points ----- Stable
 - $+5.1$ to $+10.0$ mOhms ----- 0 Points ----- Minor
 - $+10.1$ to $+15.0$ mOhms ----- 0 Points ----- Acceptable
 - $+15.1$ to $+50.0$ mOhms ----- 0 Points ----- Marginal
 - $+50.1$ to $+2000$ mOhms ----- 0 Points ----- Unstable
 - $>+2000$ mOhms ----- 0 Points ----- Open Failure
- **Humidity**
 - $\leq +5.0$ mOhms ----- 192 Points ----- Stable
 - $+5.1$ to $+10.0$ mOhms ----- 0 Points ----- Minor
 - $+10.1$ to $+15.0$ mOhms ----- 0 Points ----- Acceptable
 - $+15.1$ to $+50.0$ mOhms ----- 0 Points ----- Marginal
 - $+50.1$ to $+2000$ mOhms ----- 0 Points ----- Unstable
 - $>+2000$ mOhms ----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Mating/Unmating Durability Group (192 LLCR test points)**

SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K

- **Initial**-----6.48 mOhms Max
- **Durability, 100 Cycles**
 - **<= +5.0 mOhms**-----192 Points-----Stable
 - **+5.1 to +10.0 mOhms**-----0 Points-----Minor
 - **+10.1 to +15.0 mOhms**-----0 Points-----Acceptable
 - **+15.1 to +50.0 mOhms**-----0 Points-----Marginal
 - **+50.1 to +2000 mOhms**-----0 Points-----Unstable
 - **>+2000 mOhms**-----0 Points-----Open Failure
- **Thermal**
 - **<= +5.0 mOhms**-----192 Points-----Stable
 - **+5.1 to +10.0 mOhms**-----0 Points-----Minor
 - **+10.1 to +15.0 mOhms**-----0 Points-----Acceptable
 - **+15.1 to +50.0 mOhms**-----0 Points-----Marginal
 - **+50.1 to +2000 mOhms**-----0 Points-----Unstable
 - **>+2000 mOhms**-----0 Points-----Open Failure
- **Humidity**
 - **<= +5.0 mOhms**-----192 Points-----Stable
 - **+5.1 to +10.0 mOhms**-----0 Points-----Minor
 - **+10.1 to +15.0 mOhms**-----0 Points-----Acceptable
 - **+15.1 to +50.0 mOhms**-----0 Points-----Marginal
 - **+50.1 to +2000 mOhms**-----0 Points-----Unstable
 - **>+2000 mOhms**-----0 Points-----Open Failure

RESULTS Continued**LLCR Shock & Vibration Group (192 LLCR test points)**

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

- **Initial**-----9.50 mOhms Max
- **Shock & Vibration**
 - **<= +5.0 mOhms** ----- 192 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure

Mechanical Shock & Random Vibration:

- **Shock**
 - **No Damage**----- Pass
 - **50 Nanoseconds**----- Pass
- **Vibration**
 - **No Damage**----- Pass
 - **50 Nanoseconds**----- Pass

LLCR Shock & Vibration (192 LLCR test points)

SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K

- **Initial**-----6.92 mOhms Max
- **Shock & Vibration**
 - **<= +5.0 mOhms** ----- 192 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure

Mechanical Shock & Random Vibration:

- **Shock**
 - **No Damage**----- Pass
 - **50 Nanoseconds**----- Pass
- **Vibration**
 - **No Damage**----- Pass
 - **50 Nanoseconds**----- Pass

RESULTS Continued**LLCR Extended Life Group (192 LLCR test points)****250 cycles (SEAF-50-05.0-S-10-2-A-K-TR/ SEAM-50-02.0-S-10-2-A-K-TR)**

- **Initial**-----7.73 mOhms Max
- **Durability, 250 Cycles**
 - **<= +5.0 mOhms**-----192 Points-----Stable
 - **+5.1 to +10.0 mOhms**-----0 Points-----Minor
 - **+10.1 to +15.0 mOhms**-----0 Points-----Acceptable
 - **+15.1 to +50.0 mOhms**-----0 Points-----Marginal
 - **+50.1 to +2000 mOhms**-----0 Points-----Unstable
 - **>+2000 mOhms**-----0 Points-----Open Failure
- **Thermal Shock**
 - **<= +5.0 mOhms**-----192 Points-----Stable
 - **+5.1 to +10.0 mOhms**-----0 Points-----Minor
 - **+10.1 to +15.0 mOhms**-----0 Points-----Acceptable
 - **+15.1 to +50.0 mOhms**-----0 Points-----Marginal
 - **+50.1 to +2000 mOhms**-----0 Points-----Unstable
 - **>+2000 mOhms**-----0 Points-----Open Failure
- **Humidity**
 - **<= +5.0 mOhms**-----192 Points-----Stable
 - **+5.1 to +10.0 mOhms**-----0 Points-----Minor
 - **+10.1 to +15.0 mOhms**-----0 Points-----Acceptable
 - **+15.1 to +50.0 mOhms**-----0 Points-----Marginal
 - **+50.1 to +2000 mOhms**-----0 Points-----Unstable
 - **>+2000 mOhms**-----0 Points-----Open Failure

RESULTS Continued**LLCR Extended Life Group (192 LLCR test points)****500 cycles (SEAF-50-05.0-S-10-2-A-K-TR/ SEAM-50-02.0-S-10-2-A-K-TR)**

- **Initial**-----7.13 mOhms Max
- **Durability, 500 Cycles**
 - **<= +5.0 mOhms** ----- 192 Points ----- Stable
 - **+5.1 to +10.0 mOhms**-----0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** -----0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** -----0 Points ----- Marginal
 - **+50.1 to +2000 mOhms**-----0 Points ----- Unstable
 - **>+2000 mOhms**-----0 Points ----- Open Failure
- **Thermal Shock**
 - **<= +5.0 mOhms** ----- 192 Points ----- Stable
 - **+5.1 to +10.0 mOhms**-----0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** -----0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** -----0 Points ----- Marginal
 - **+50.1 to +2000 mOhms**-----0 Points ----- Unstable
 - **>+2000 mOhms**-----0 Points ----- Open Failure
- **Humidity**
 - **<= +5.0 mOhms** ----- 192 Points ----- Stable
 - **+5.1 to +10.0 mOhms**-----0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** -----0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** -----0 Points ----- Marginal
 - **+50.1 to +2000 mOhms**-----0 Points ----- Unstable
 - **>+2000 mOhms**-----0 Points ----- Open Failure

1000 cycles (SEAF-50-05.0-S-10-2-A-K-TR/ SEAM-50-02.0-S-10-2-A-K-TR)

- **Initial**-----7.35 mOhms Max
- **Durability, 1000 Cycles**
 - **<= +5.0 mOhms** ----- 192 Points ----- Stable
 - **+5.1 to +10.0 mOhms**-----0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** -----0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** -----0 Points ----- Marginal
 - **+50.1 to +2000 mOhms**-----0 Points ----- Unstable
 - **>+2000 mOhms**-----0 Points ----- Open Failure
- **Thermal Shock**
 - **<= +5.0 mOhms** ----- 192 Points ----- Stable
 - **+5.1 to +10.0 mOhms**-----0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** -----0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** -----0 Points ----- Marginal
 - **+50.1 to +2000 mOhms**-----0 Points ----- Unstable
 - **>+2000 mOhms**-----0 Points ----- Open Failure
- **Humidity**
 - **<= +5.0 mOhms** ----- 190 Points ----- Stable
 - **+5.1 to +10.0 mOhms**-----2 Points ----- Minor
 - **+10.1 to +15.0 mOhms** -----0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** -----0 Points ----- Marginal
 - **+50.1 to +2000 mOhms**-----0 Points ----- Unstable
 - **>+2000 mOhms**-----0 Points ----- Open Failure

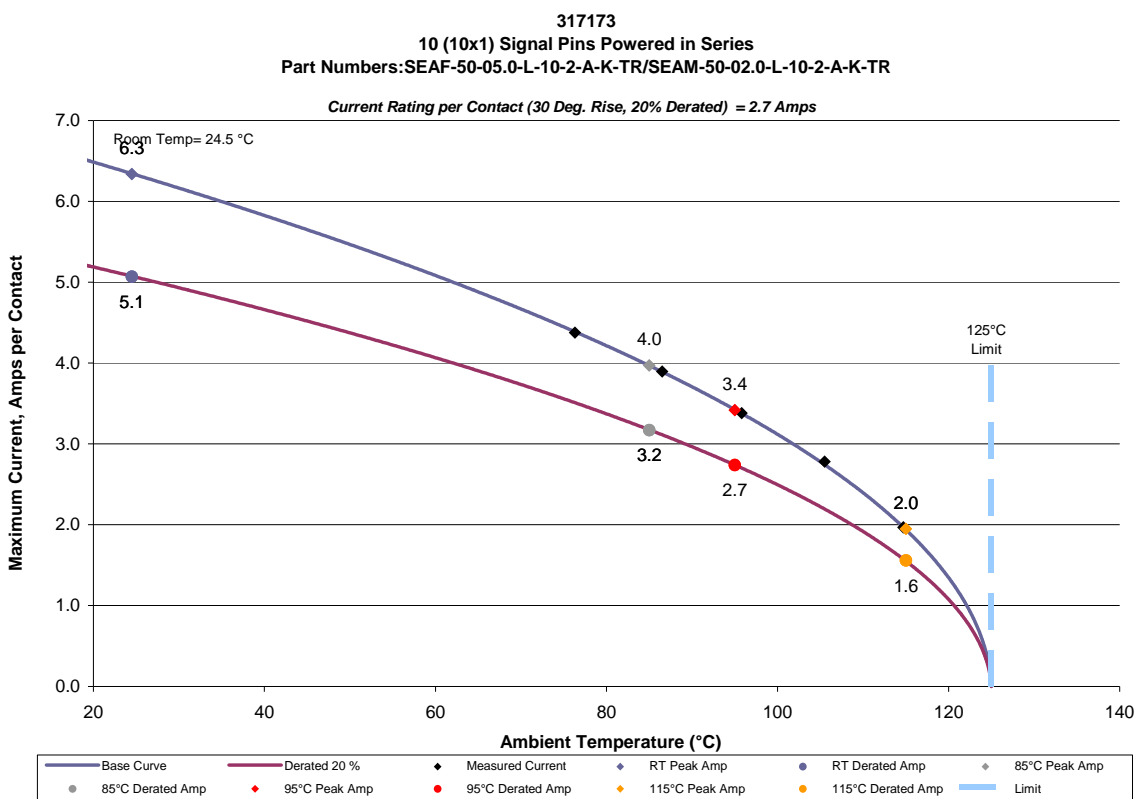
DATA SUMMARIES

TEMPERATURE RISE (Current Carrying Capacity, CCC):

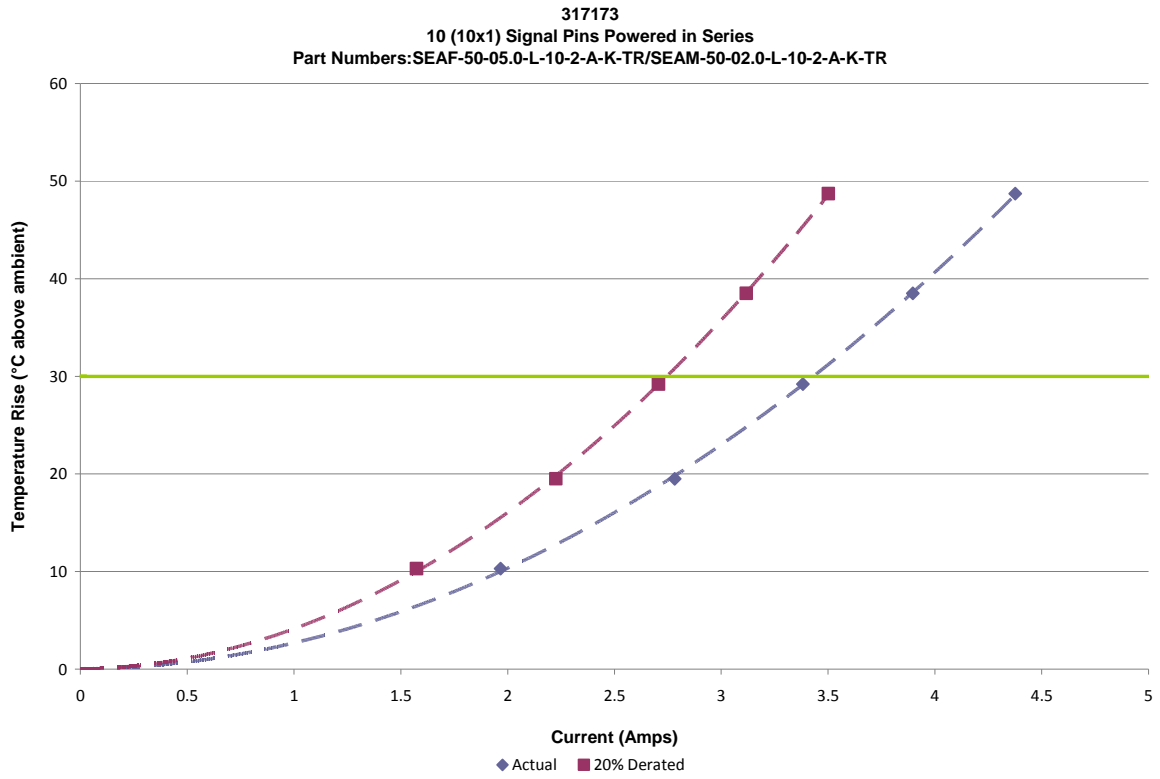
- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
- 4) Adjacent contacts were powered:

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

- a. Linear configuration with 10 adjacent conductors/contacts powered

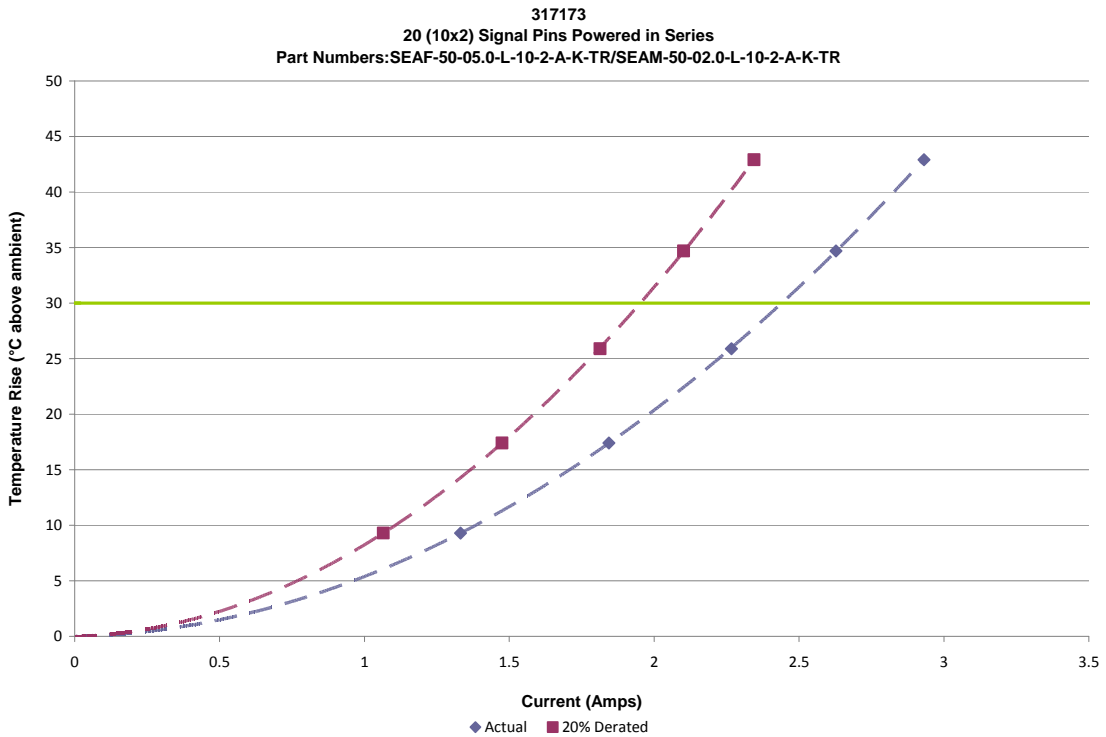
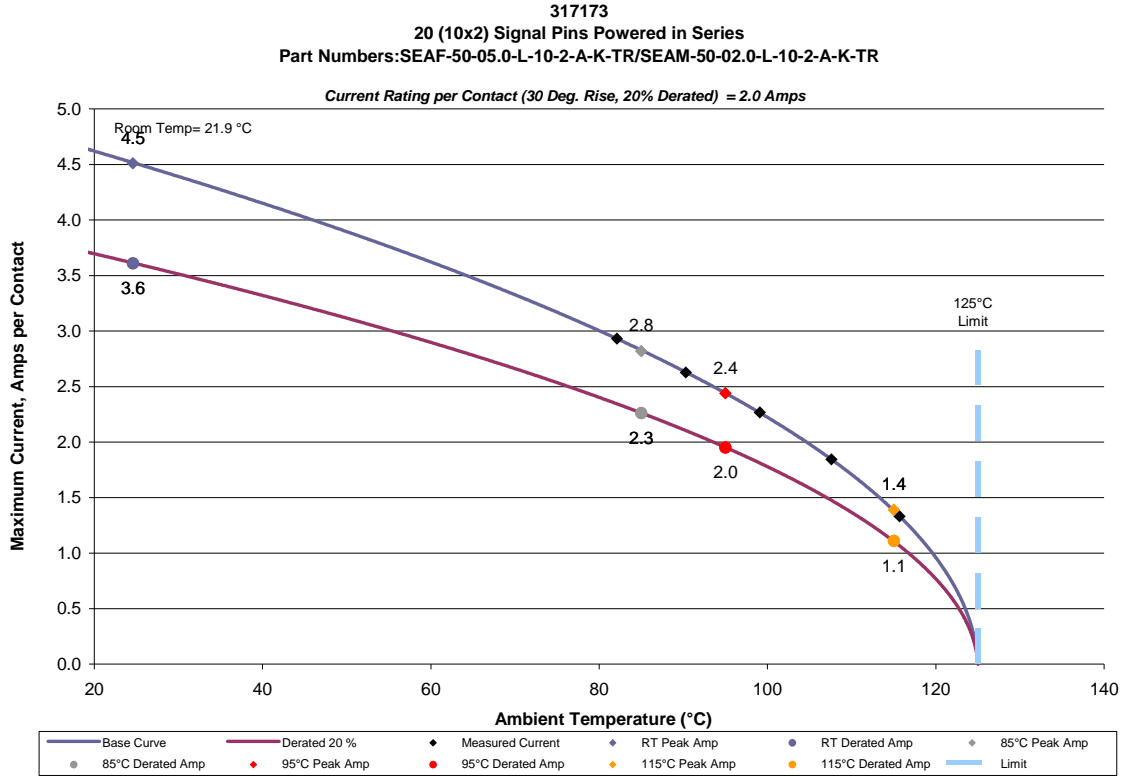


DATA SUMMARIES Continued



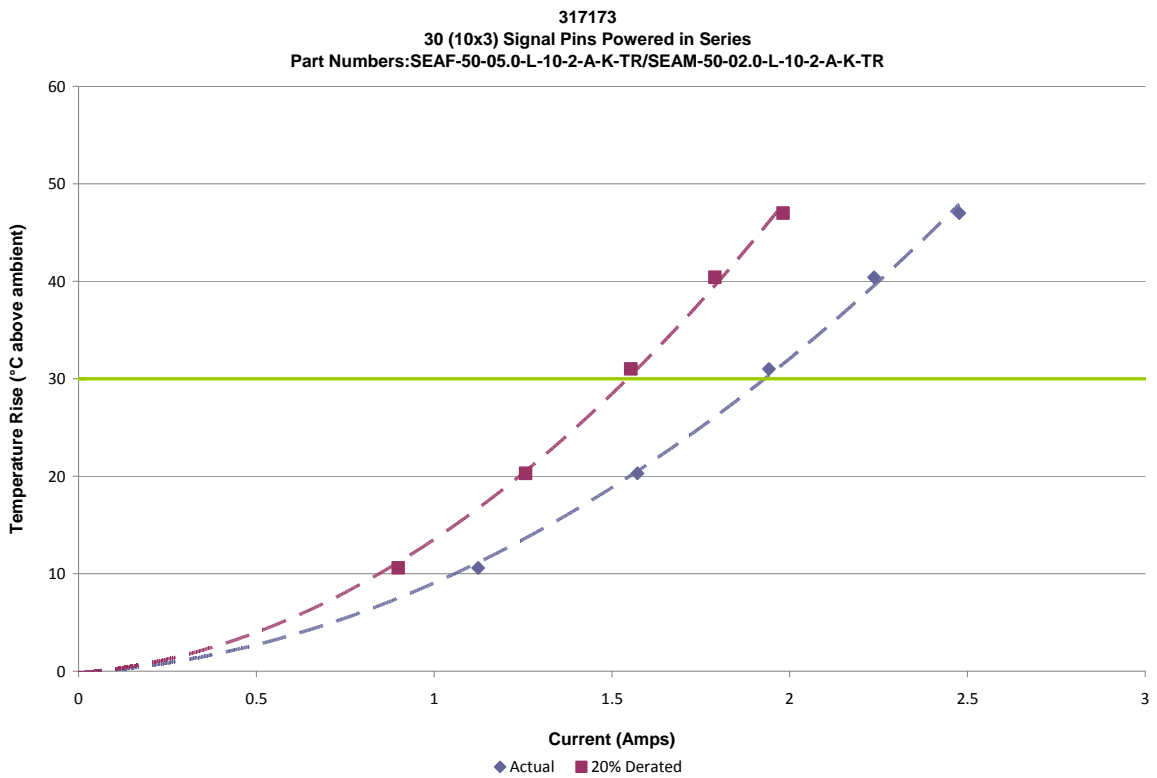
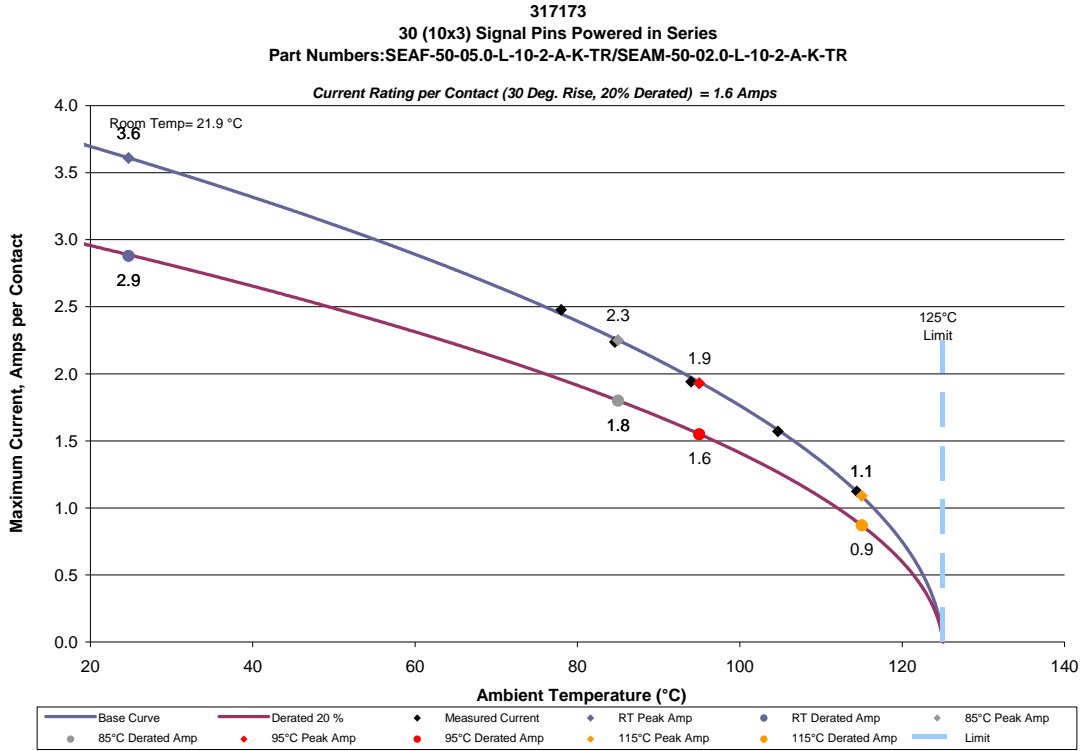
DATA SUMMARIES Continued

b. Linear configuration with 20 adjacent conductors/contacts powered



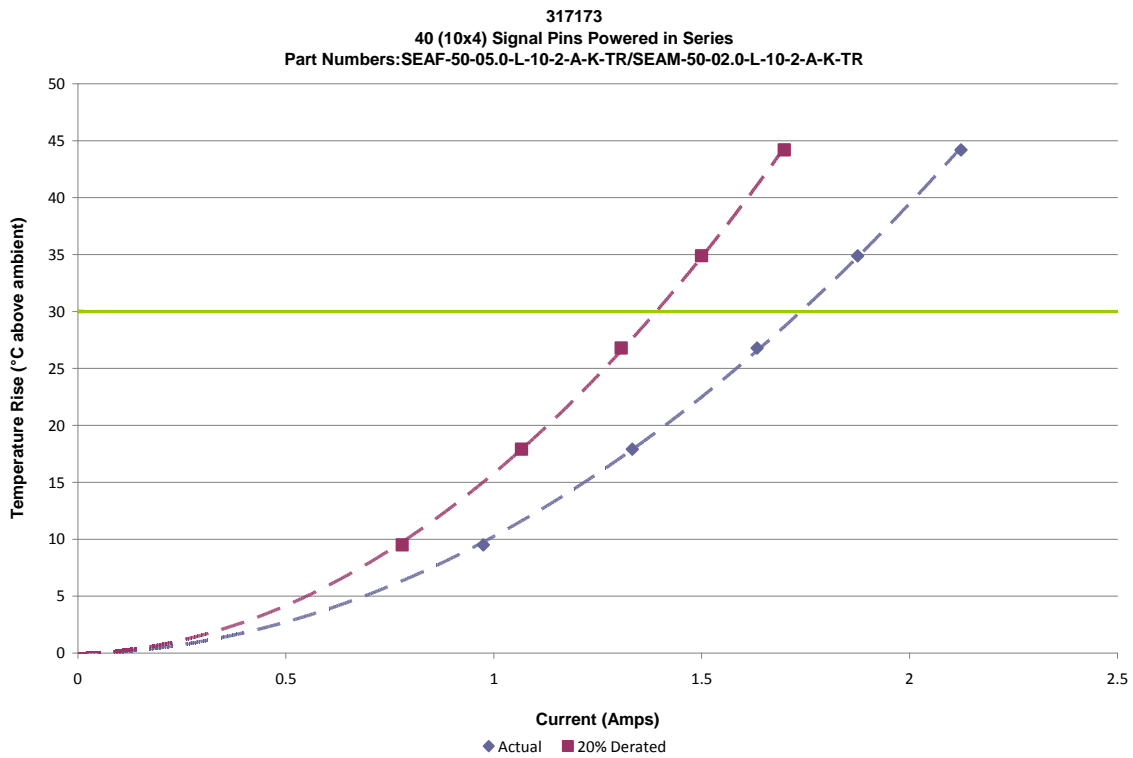
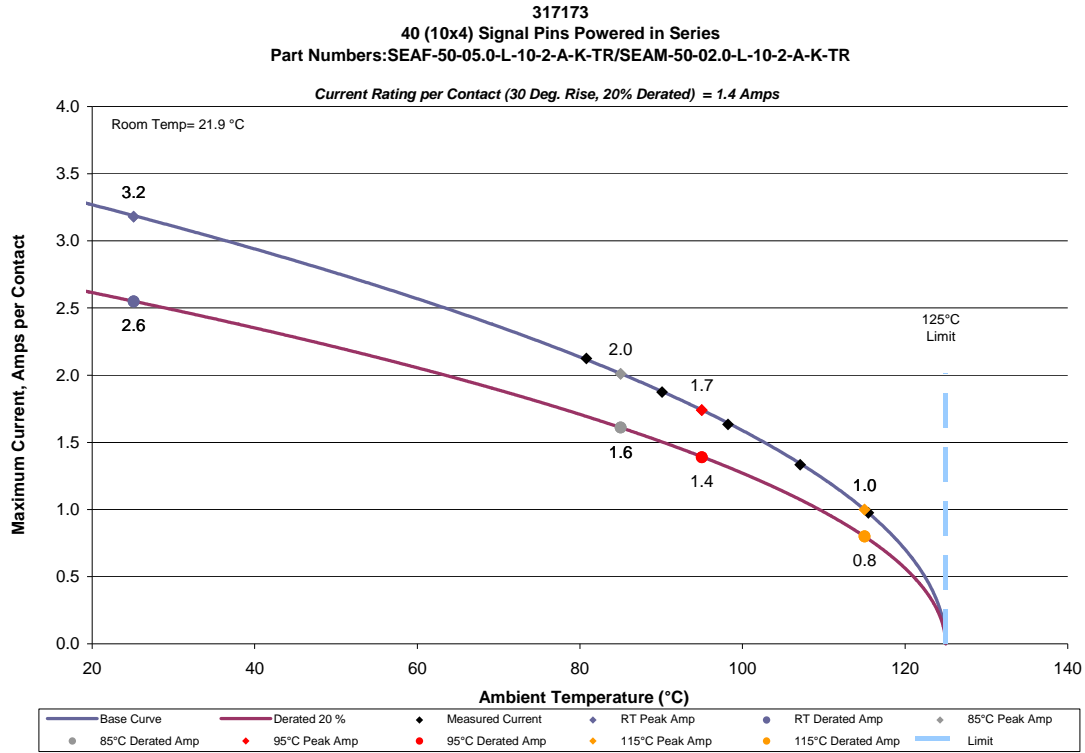
DATA SUMMARIES Continued

c. Linear configuration with 30 adjacent conductors/contacts powered



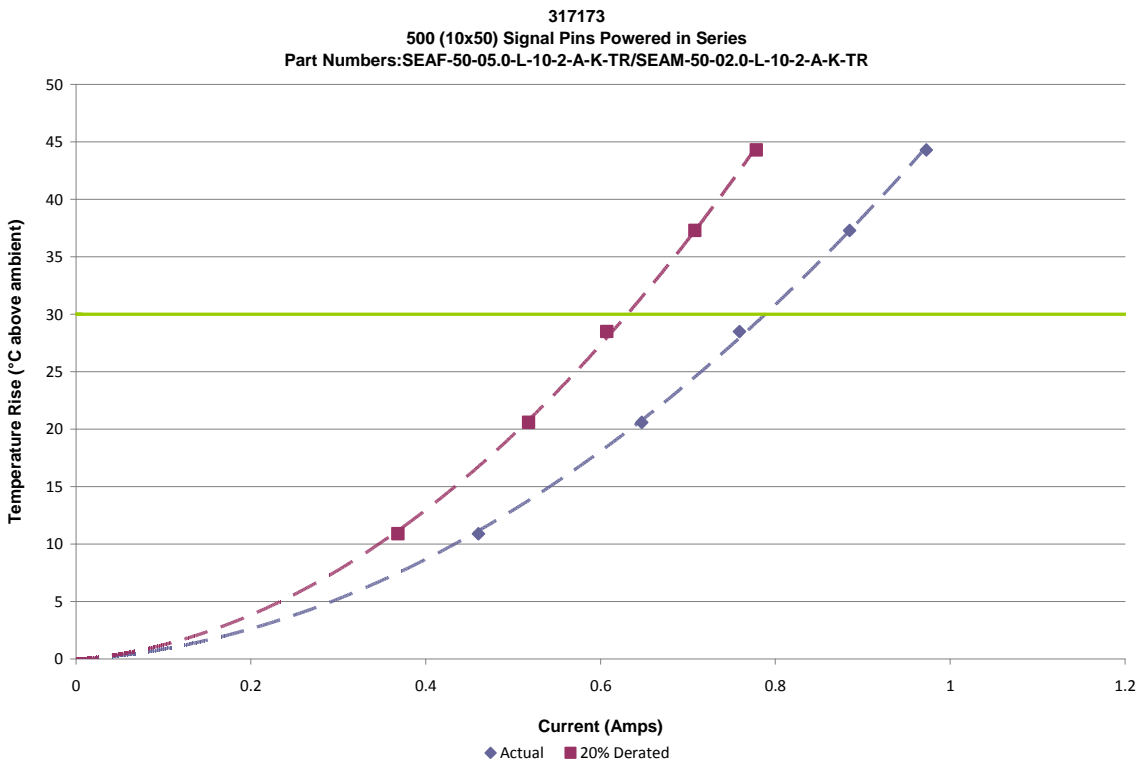
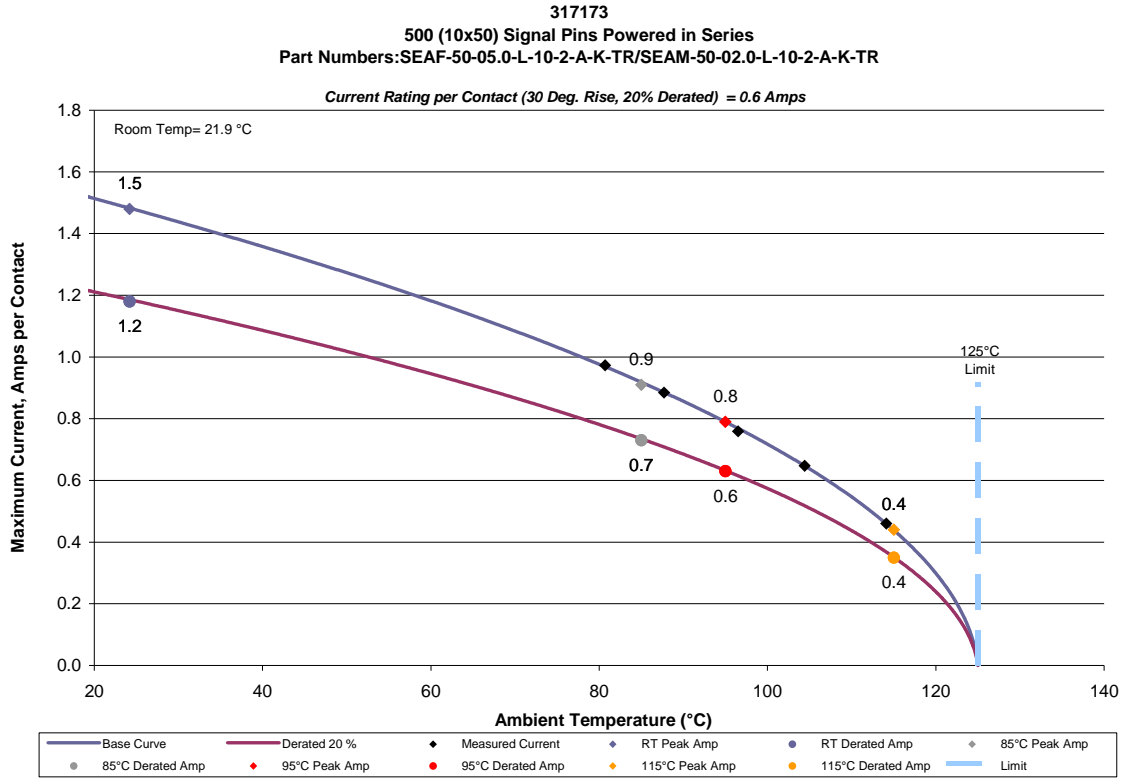
DATA SUMMARIES Continued

d. Linear configuration with 40 adjacent conductors/contacts powered



DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered



DATA SUMMARIES Continued

SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K

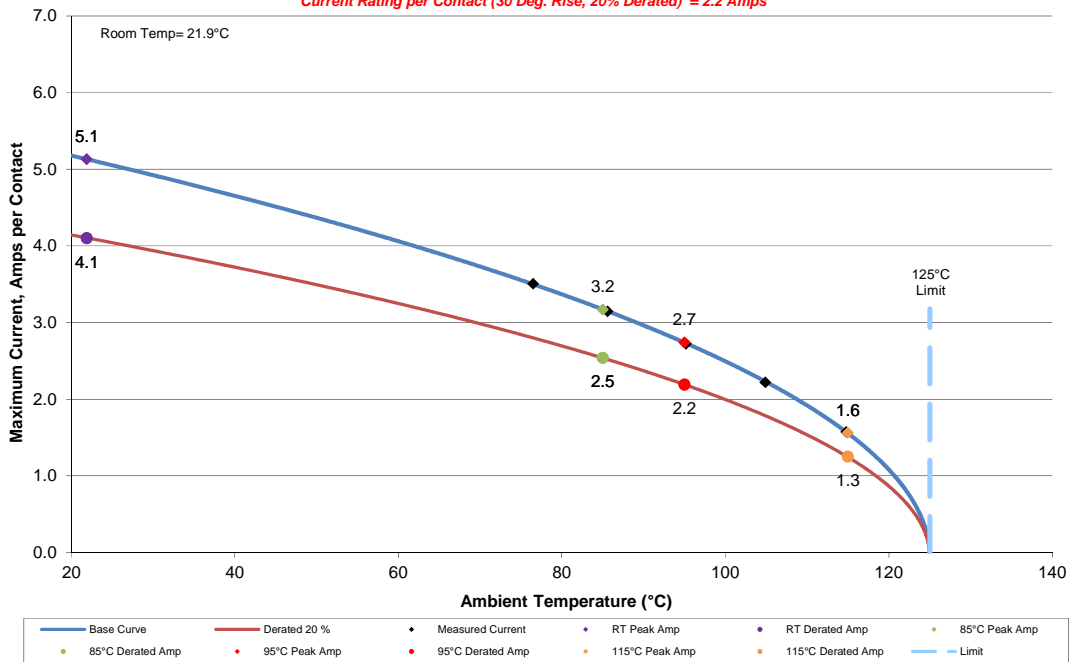
a) Linear configuration with 14 adjacent conductors/contacts powered

668291

14 (14x1) Contacts in Series

Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

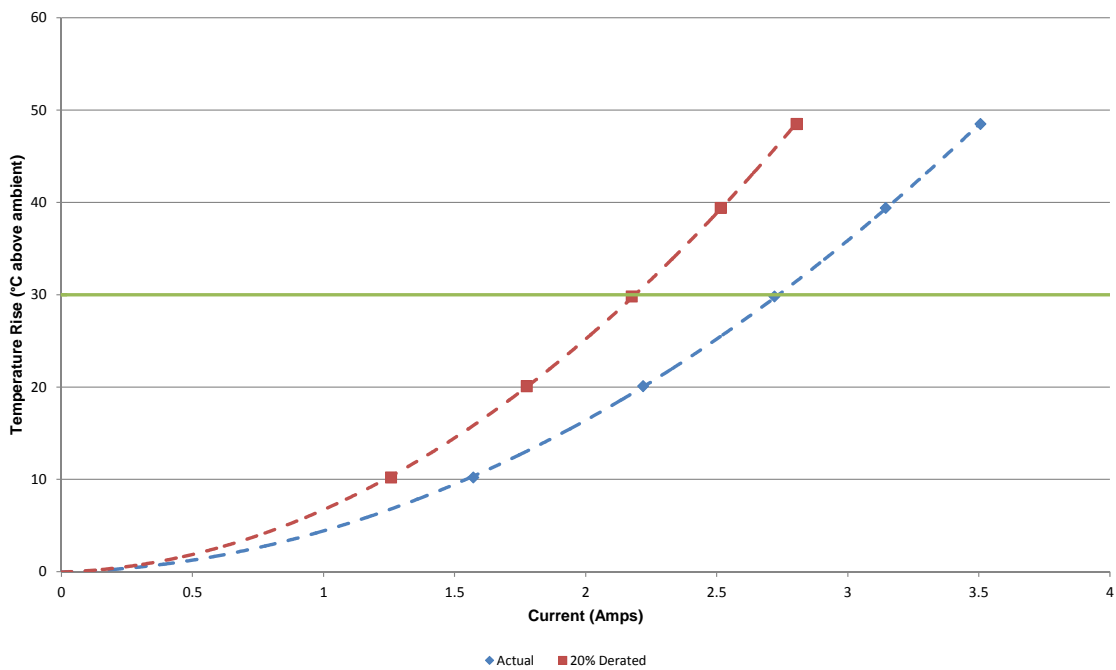
Current Rating per Contact (30 Deg. Rise, 20% Derated) = 2.2 Amps



668291

14 (14x1) Contacts in Series

Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

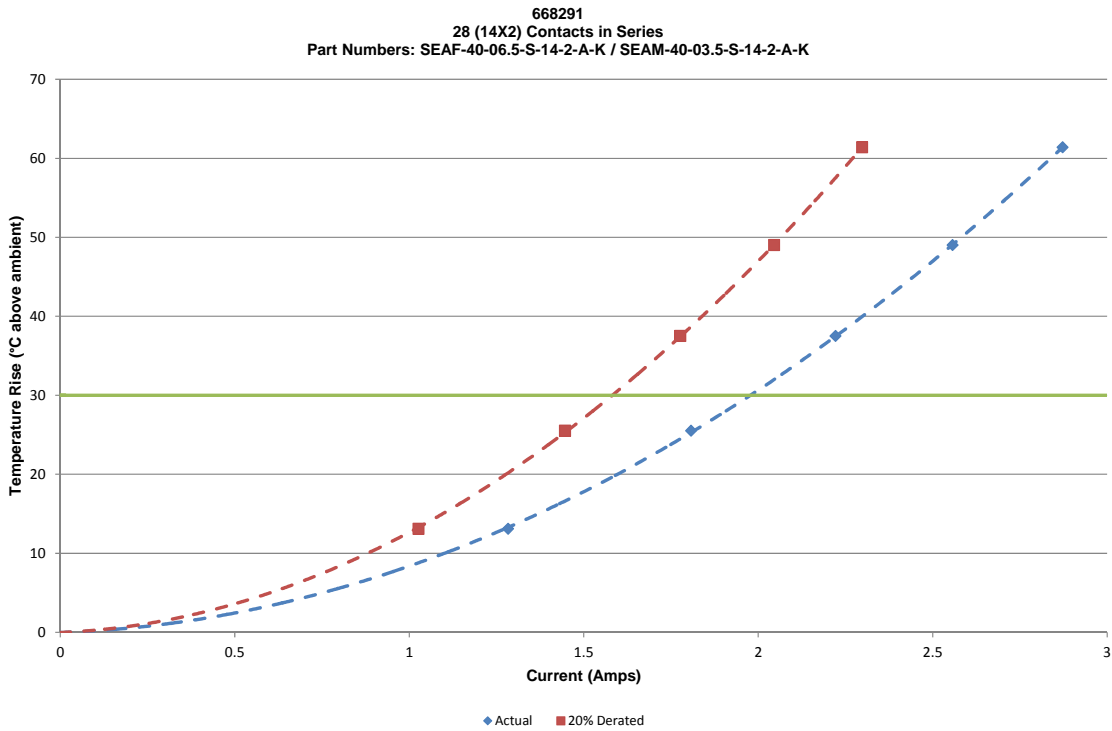
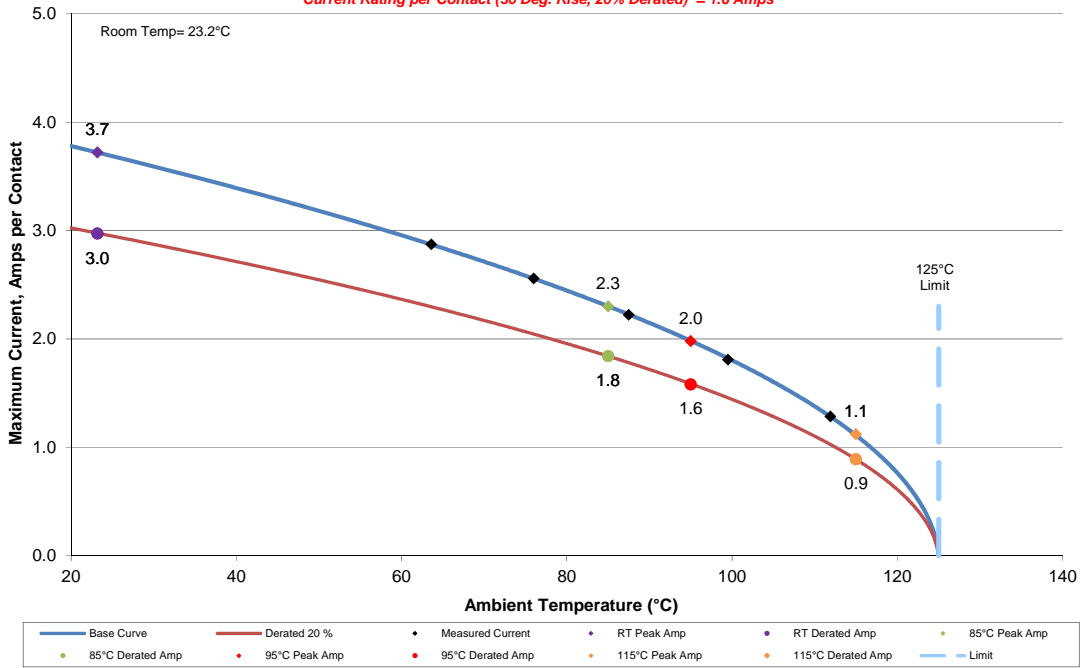


DATA SUMMARIES Continued

b) Linear configuration with 28 adjacent conductors/contacts powered

668291
28 (14X2) Contacts in Series
Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 1.6 Amps

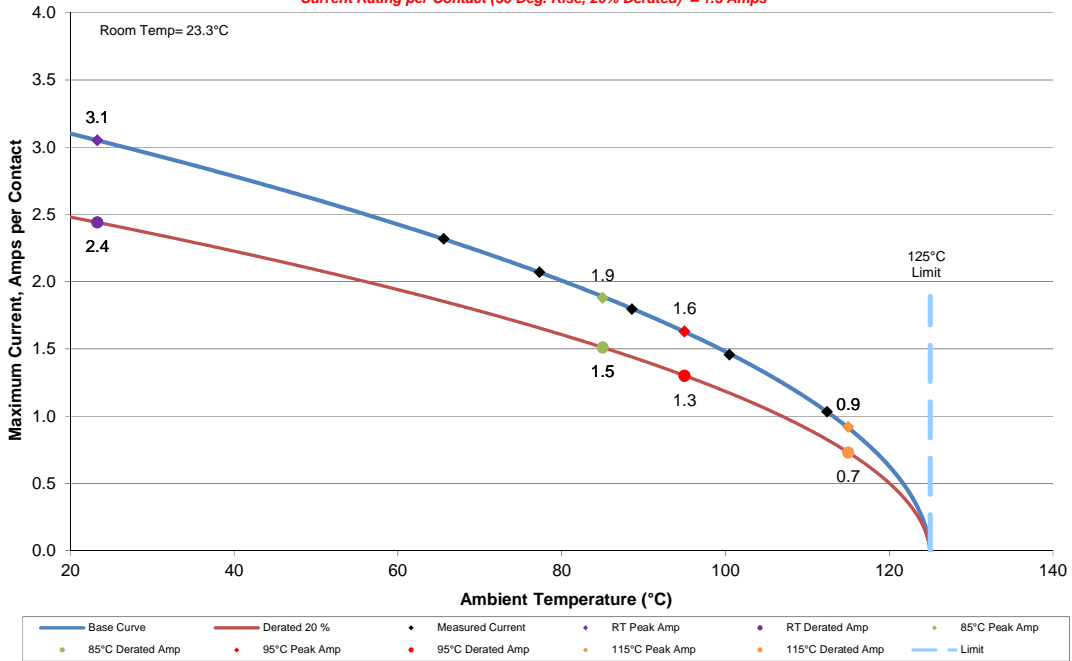


DATA SUMMARIES Continued

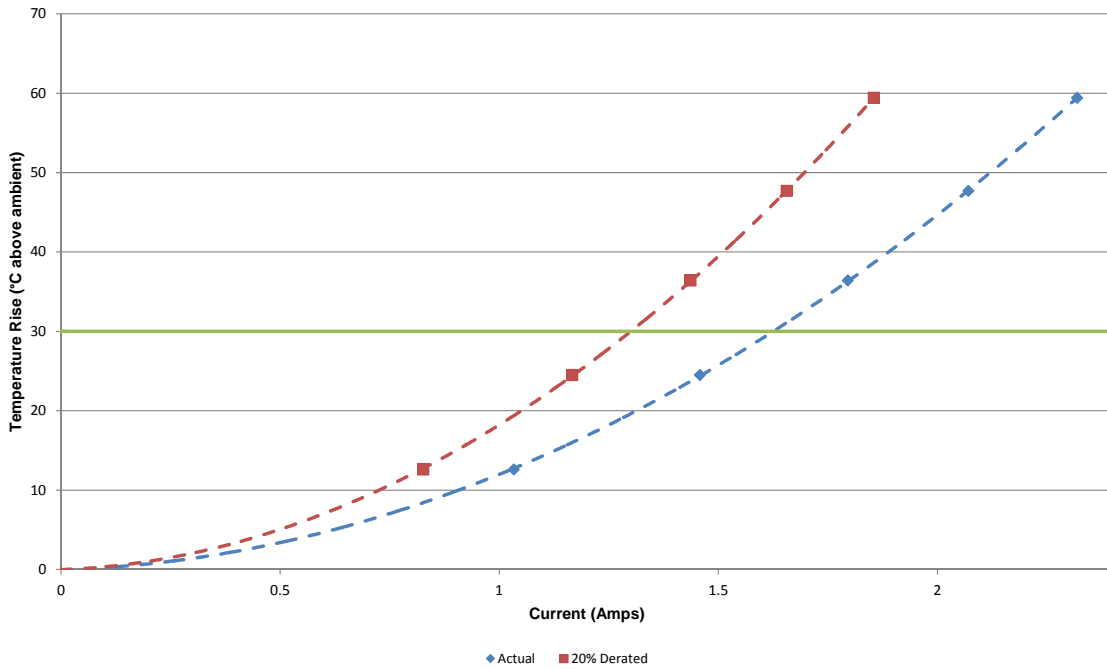
c) Linear configuration with 42 adjacent conductors/contacts powered

668291
 42 (14X3) Contacts in Series
 Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 1.3 Amps



668291
 42 (14X3) Contacts in Series
 Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

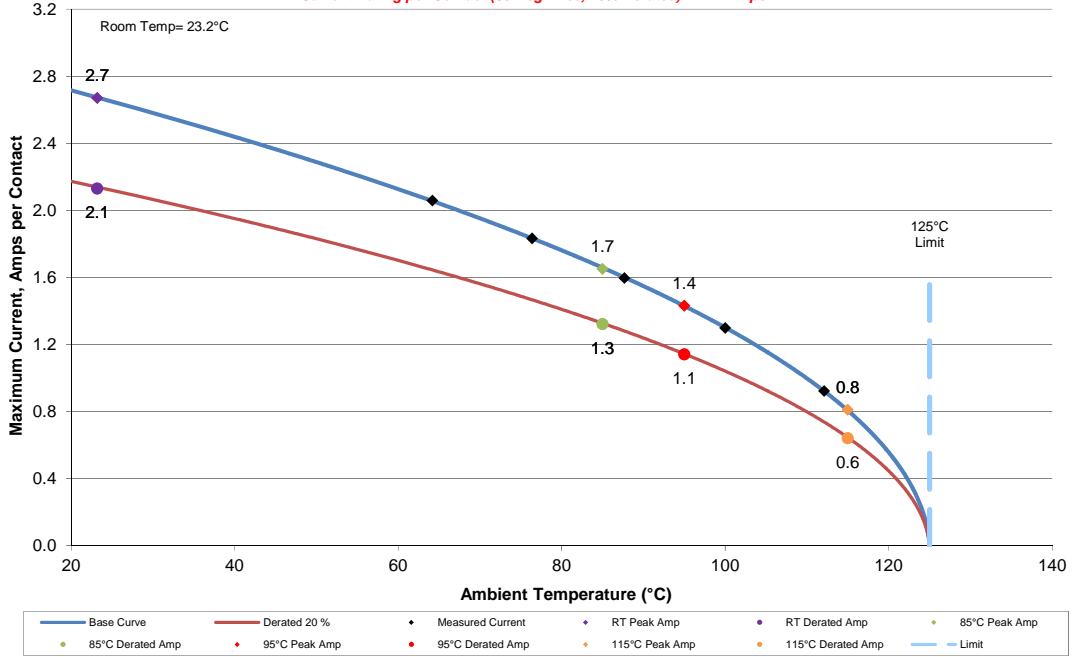


DATA SUMMARIES Continued

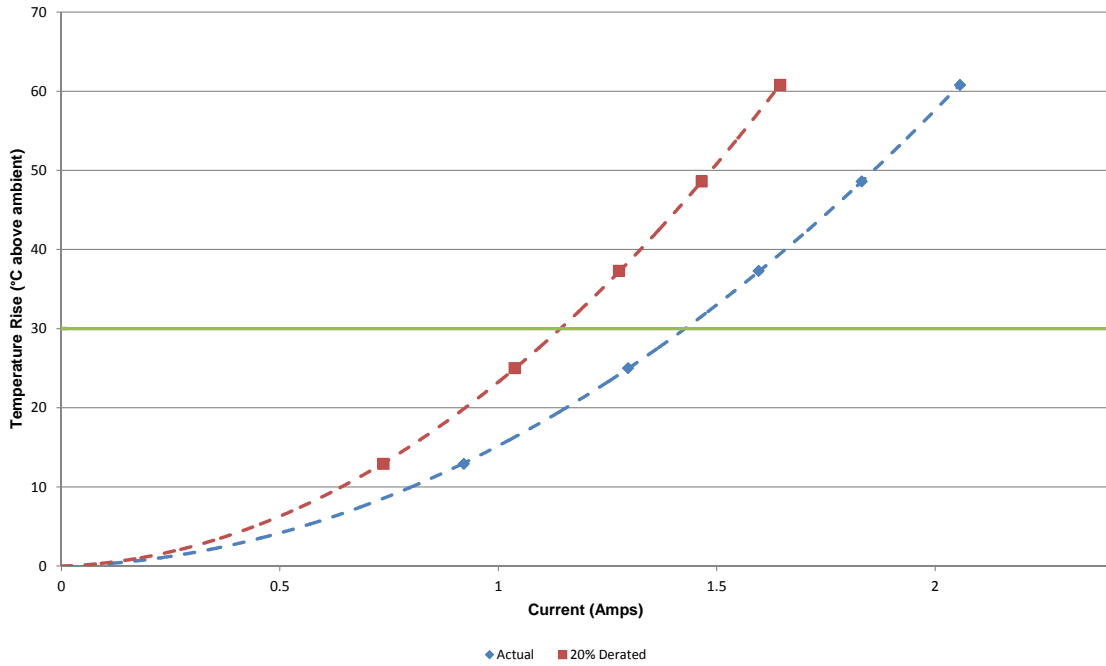
d) Linear configuration with 56 adjacent conductors/contacts powered

668291
56 (14X4) Contacts in Series
Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 1.1 Amps



668291
56 (14X4) Contacts in Series
Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

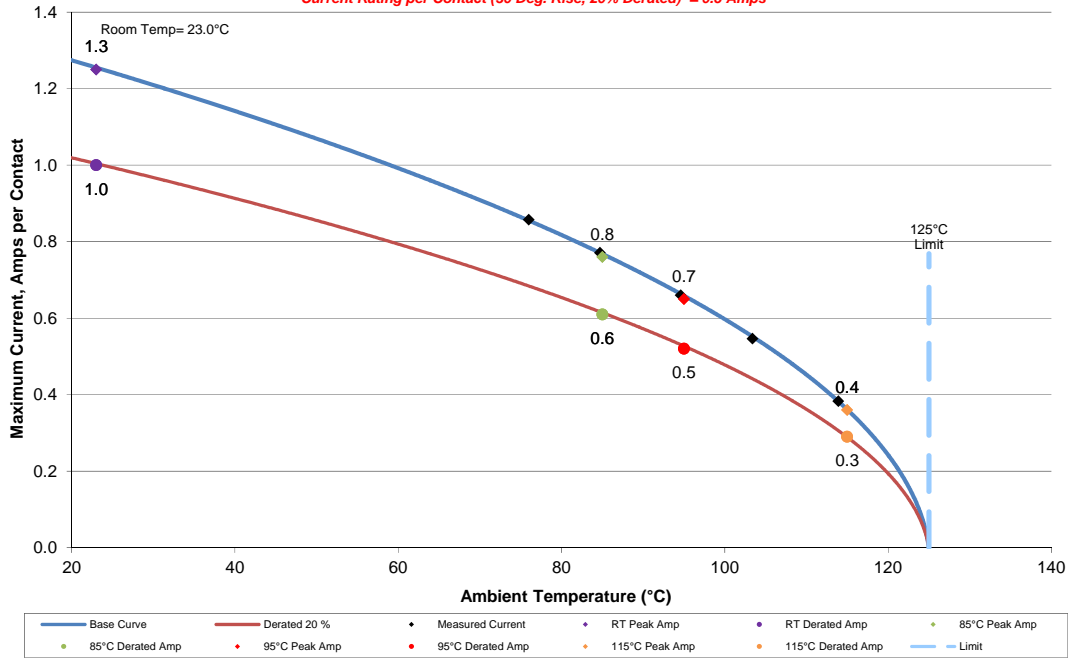


DATA SUMMARIES Continued

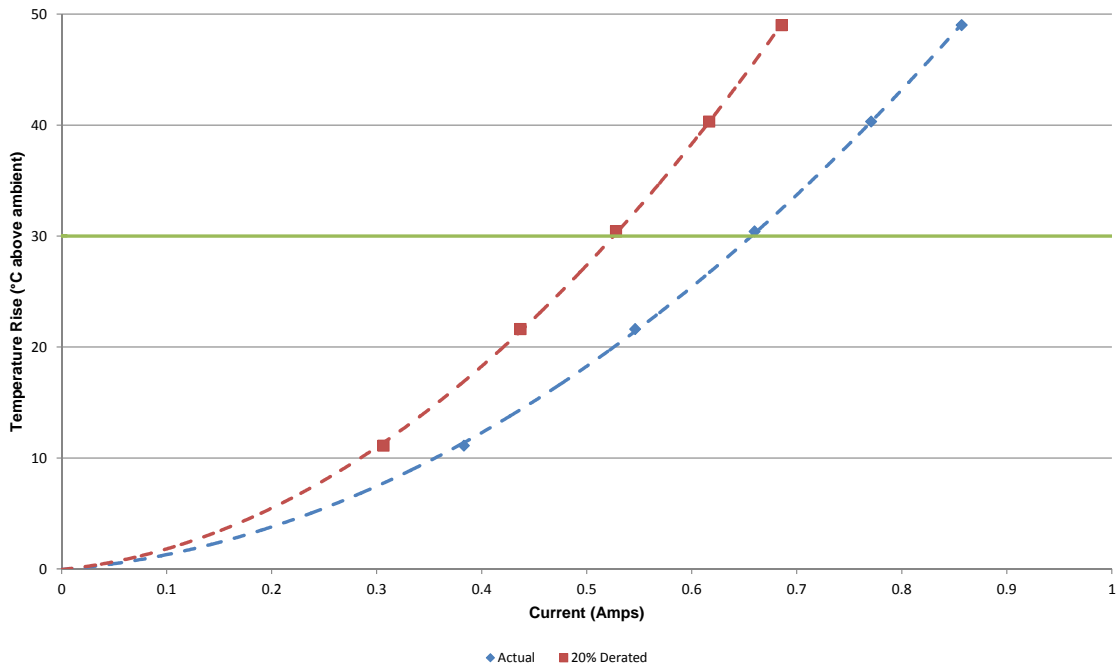
e) Linear configuration with all adjacent conductors/contacts powered

668291
 560 (14X40)(All Power) Contacts in Series
 Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 0.5 Amps



668291
 560 (14X40)(All Power) Contacts in Series
 Part Numbers: SEAF-40-06.5-S-14-2-A-K / SEAM-40-03.5-S-14-2-A-K



DATA SUMMARIES Continued

MATING-UNMATING FORCE:

Thermal Aging Group (SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR)

	Initial				After Thermals			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	74.64	16.78	42.88	9.64	60.89	13.69	38.52	8.66
Maximum	103.77	23.33	58.31	13.11	69.79	15.69	44.92	10.10
Average	88.94	20.00	52.02	11.70	65.67	14.76	41.58	9.35
St Dev	8.94	2.01	5.32	1.20	3.33	0.75	2.61	0.59
Count	8	8	8	8	8	8	8	8

Mating-Unmating Durability Group (SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR)

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	84.96	19.10	43.41	9.76	88.87	19.98	49.33	11.09
Maximum	96.66	21.73	57.16	12.85	101.33	22.78	63.52	14.28
Average	91.97	20.68	49.06	11.03	97.55	21.93	57.53	12.94
St Dev	4.31	0.97	5.56	1.25	5.11	1.15	5.24	1.18
Count	8	8	8	8	8	8	8	8

	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	90.12	20.26	54.71	12.30	92.83	20.87	58.09	13.06
Maximum	107.24	24.11	67.61	15.20	107.86	24.25	70.28	15.80
Average	100.26	22.54	60.94	13.70	102.93	23.14	64.46	14.49
St Dev	6.10	1.37	4.98	1.12	6.18	1.39	4.58	1.03
Count	7	7	8	8	8	8	8	8

	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	94.56	21.26	60.80	13.67	66.68	14.99	28.38	6.38
Maximum	111.64	25.10	72.19	16.23	78.33	17.61	38.16	8.58
Average	105.28	23.67	67.20	15.11	71.30	16.03	32.78	7.37
St Dev	6.50	1.46	4.88	1.10	3.76	0.85	3.29	0.74
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued

Mating-Unmating Basic (SEAF-30-05.0-L-08-2-A-K-TR / SEAM-30-02.0-L-08-2-A-K-TR)

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)
Minimum	55.78	12.54	31.36	7.05	63.92	14.37	38.48	8.65
Maximum	66.99	15.06	41.77	9.39	81.53	18.33	46.88	10.54
Average	61.04	13.72	35.32	7.94	70.40	15.83	41.91	9.42
St Dev	3.69	0.83	3.08	0.69	5.66	1.27	3.09	0.70
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)
Minimum	62.41	14.03	41.37	9.30	62.45	14.04	45.19	10.16
Maximum	79.62	17.90	50.22	11.29	77.26	17.37	54.09	12.16
Average	73.13	16.44	45.29	10.18	71.31	16.03	48.40	10.88
St Dev	5.14	1.16	3.09	0.70	4.96	1.11	3.09	0.70
Count	8	8	8	8	8	8	8	8
	After 100 Cycles							
	Mating		Unmating					
	Newton	Force (Lbs)	Newton	Force (Lbs)				
Minimum	63.30	14.23	46.93	10.55				
Maximum	79.04	17.77	56.18	12.63				
Average	72.09	16.21	50.61	11.38				
St Dev	4.89	1.10	3.20	0.72				
Count	8	8	8	8				

DATA SUMMARIES Continued**Mating-Unmating Basic (SEAF-10-05.0-L-04-2-A-K-TR / SEAM-10-02.0-L-04-2-A-K-TR)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	10.27	2.31	5.07	1.14	10.68	2.40	6.00	1.35
Maximum	12.10	2.72	7.16	1.61	13.61	3.06	8.45	1.90
Average	11.14	2.50	5.85	1.32	11.72	2.64	7.42	1.67
St Dev	0.55	0.12	0.61	0.14	0.85	0.19	0.78	0.18
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	10.90	2.45	5.87	1.32	10.99	2.47	5.87	1.32
Maximum	14.10	3.17	8.98	2.02	14.90	3.35	9.21	2.07
Average	11.61	2.61	7.78	1.75	11.72	2.64	8.00	1.80
St Dev	1.03	0.23	0.98	0.22	1.30	0.29	1.02	0.23
Count	8	8	8	8	8	8	8	8
	After 100 Cycles							
	Mating		Unmating					
	Newton's	Force (Lbs)	Newton's	Force (Lbs)				
Minimum	10.99	2.47	5.78	1.30				
Maximum	15.35	3.45	9.34	2.10				
Average	11.84	2.66	7.97	1.79				
St Dev	1.46	0.33	1.10	0.25				
Count	8	8	8	8				

DATA SUMMARIES Continued

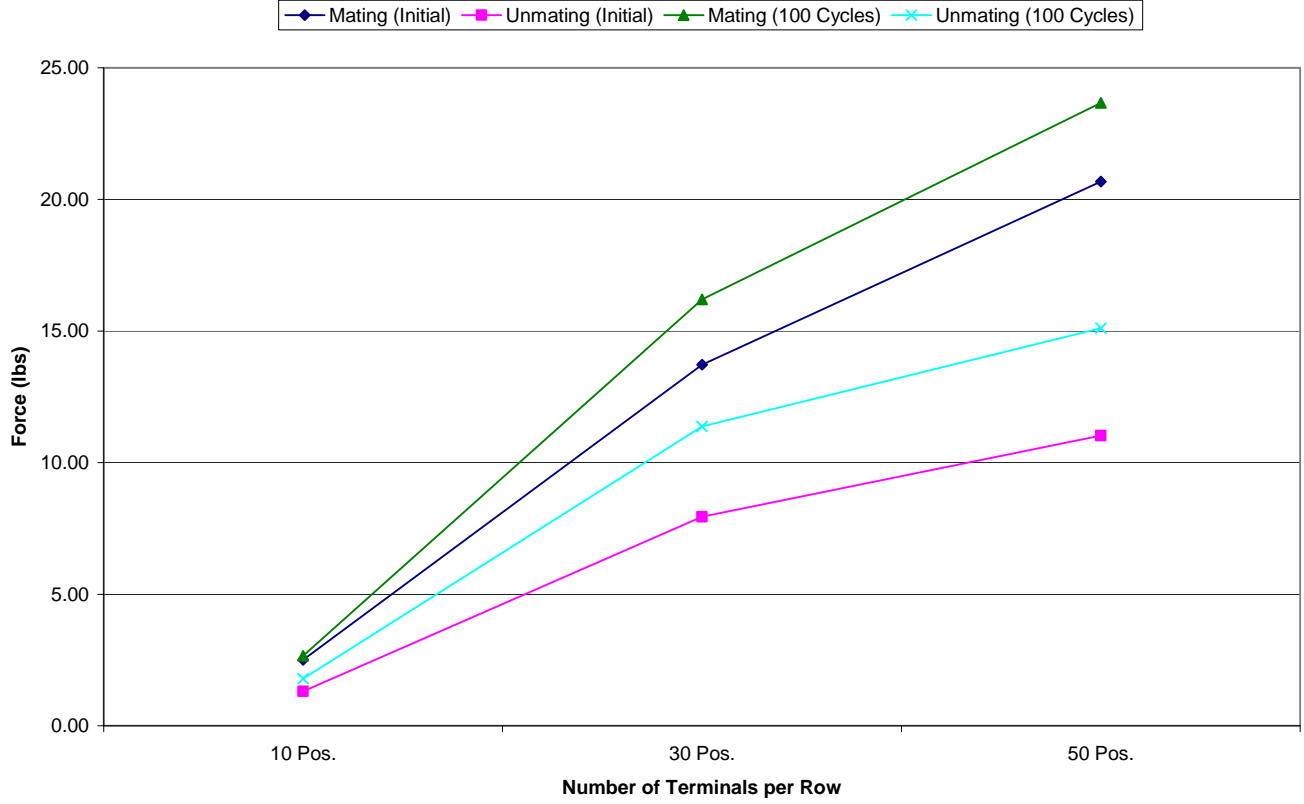
Mating\Unmating Durability Group (SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K)

	Initial				25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	125.69	28.26	87.41	19.65	132.68	29.83	101.77	22.88
Maximum	159.21	35.79	111.01	24.96	168.85	37.96	127.81	28.74
Average	142.34	32.00	102.42	23.03	154.09	34.64	108.89	24.48
St Dev	12.84	2.89	8.34	1.88	11.28	2.53	8.37	1.88
Count	8	8	8	8	8	8	8	8
	50 Cycles				75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	127.33	28.63	102.69	23.09	129.05	29.01	105.14	23.64
Maximum	160.57	36.10	128.19	28.82	162.41	36.51	133.08	29.92
Average	146.44	32.92	110.67	24.88	147.79	33.23	113.61	25.54
St Dev	10.84	2.44	8.16	1.84	11.70	2.63	8.59	1.93
Count	8	8	8	8	8	8	8	8
	100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	132.48	29.79	105.57	23.74	99.49	22.37	50.24	11.30
Maximum	168.25	37.83	135.66	30.50	129.48	29.11	93.72	21.07
Average	151.85	34.14	115.34	25.93	114.70	25.79	78.77	17.71
St Dev	13.20	2.97	9.30	2.09	11.14	2.50	14.01	3.15
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued

Mating\Unmating Force Comparison

Mating/Unmating Data for 10, 30 and 50 Position SEAF/SEAM



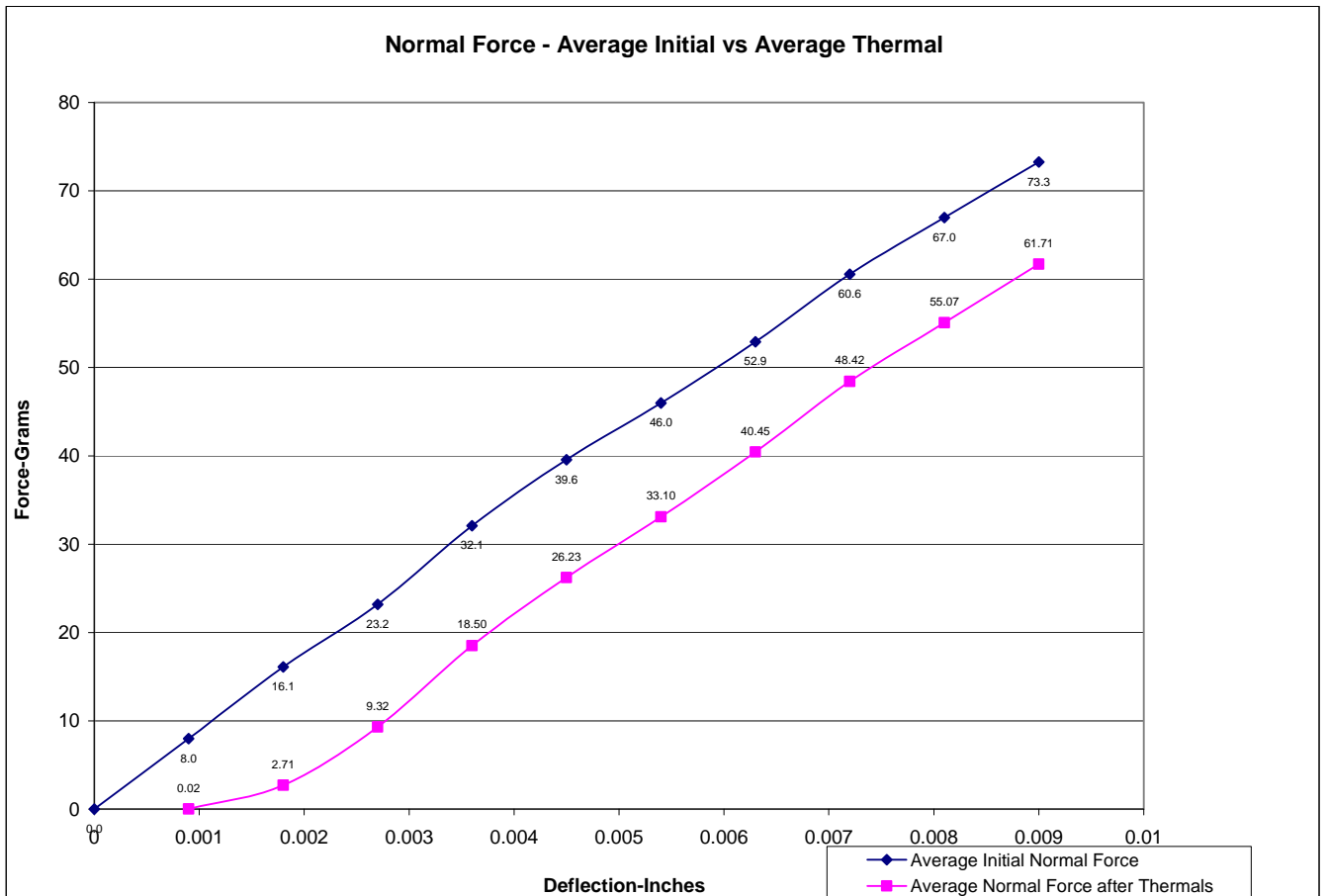
DATA SUMMARIES Continued

NORMAL FORCE (FOR CONTACTS TESTED OUT THE HOUSING):

- 1) Calibrated force gauges are used along with computer controlled positioning equipment.
- 2) For Normal force 8-10 measurements are taken and the averages reported.

Initial	Deflections in inches Forces in Grams										
	<u>0.0009</u>	<u>0.0018</u>	<u>0.0027</u>	<u>0.0036</u>	<u>0.0045</u>	<u>0.0054</u>	<u>0.0063</u>	<u>0.0072</u>	<u>0.0081</u>	<u>0.0090</u>	<i>SET</i>
Averages	7.99	16.09	23.18	32.09	39.55	45.99	52.90	60.57	66.98	73.27	0.0008
Min	7.40	15.20	22.20	29.90	37.50	44.00	50.30	57.70	63.10	68.80	0.0007
Max	8.90	17.00	25.10	33.80	41.40	48.10	55.00	62.80	69.90	76.50	0.0009
St. Dev	0.450	0.500	0.847	1.174	1.334	1.485	1.634	1.831	2.345	2.650	0.0001
Count	12	12	12	12	12	12	12	12	12	12	12

After Thermals	Deflections in inches Forces in Grams										
	<u>0.0009</u>	<u>0.0018</u>	<u>0.0027</u>	<u>0.0036</u>	<u>0.0045</u>	<u>0.0054</u>	<u>0.0063</u>	<u>0.0072</u>	<u>0.0081</u>	<u>0.0090</u>	<i>SET</i>
Averages	0.02	2.71	9.32	18.50	26.23	33.10	40.45	48.42	55.07	61.71	0.0020
Min	-0.10	-0.10	2.20	11.80	19.40	27.10	34.50	42.80	50.10	56.00	0.0014
Max	0.50	8.20	14.80	24.90	32.90	40.30	47.70	55.90	62.00	69.10	0.0027
St. Dev	0.175	2.960	4.089	4.093	4.073	4.032	4.102	4.122	4.054	4.039	0.0004
Count	12	12	12	12	12	12	12	12	12	12	12



DATA SUMMARIES Continued**INSULATION RESISTANCE (IR):**

Minimum	Pin to Pin		
	Mated	Unmated	Unmated
	SEAF/SEAM	SEAF	SEAM
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

Minimum	Row to Row		
	Mated	Unmated	Unmated
	SEAF/SEAM	SEAF	SEAM
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	SEAF/SEAM
Break Down Voltage	1000
Test Voltage	750
Working Voltage	250

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**LLCR Thermal Aging Group**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms: -----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms: -----Unstable
 - f. $>+2000$ mOhms: -----Open Failure

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

LLCR Measurement Summaries by Pin Type				
Date	5/9/2014	5/20/2014		
Room Temp (Deg C)	21	21		
Rel Humidity (%)	54	54		
Technician	Peter Chen	Peter Chen		
mOhm values	Actual Initial	Delta Thermal	Delta	Delta
Pin Type 1: Signal				
Average	5.55	0.31		
St. Dev.	0.57	0.25		
Min	4.64	0.00		
Max	7.87	1.60		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Thermal	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Mating/Unmating Durability Group**

- 1). A total of 192 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:-----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:-----Marginal
 - e. $+50.1$ to $+2000$ mOhms-----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

LLCR Measurement Summaries by Pin Type				
Date	5/9/2014	5/13/2014	5/21/2014	6/3/2014
Room Temp (Deg C)	21	21	21	21
Rel Humidity (%)	56	54	54	54
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	5.93	0.60	0.75	0.55
St. Dev.	0.58	0.45	0.68	0.45
Min	4.69	0.01	0.00	0.01
Max	7.70	2.71	3.56	2.41
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
100 Cycles	192	0	0	0	0	0
Therm Shck	192	0	0	0	0	0
Humidity	192	0	0	0	0	0

SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K

LLCR Measurement Summaries by Pin Type				
Date	9/29/2015	10/7/2015	10/12/2015	10/23/2015
Room Temp (Deg C)	22	22	22	24
Rel Humidity (%)	45	48	46	40
Technician	Tony Wagoner	Tony Wagoner	Tony Wagoner	Tony Wagoner
mOhm values	Actual	Delta	Delta Therm Shck	Delta Humidity
	Initial	100 Cycles		
Pin Type 1: Signal				
Average	5.82	0.24	0.41	0.45
St. Dev.	0.27	0.20	0.24	0.26
Min	4.90	0.00	0.00	0.01
Max	6.48	0.96	1.20	1.15
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
mOhms	Stable	Minor	Acceptable	Marginal	Unstable	Open
	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
100 Cycles	192	0	0	0	0	0
Therm Shck	192	0	0	0	0	0
Humidity	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Gas Tight Group**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:-----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:-----Marginal
 - e. $+50.1$ to $+2000$ mOhms:-----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-T

LLCR Measurement Summaries by Pin Type				
Date	5/26/2014	5/27/2014		
Room Temp (Deg C)	21	21		
Rel Humidity (%)	54	54		
Technician	Peter Chen	Peter Chen		
mOhm values	Actual Initial	Delta Acid Vapor	Delta	Delta
Pin Type 1: Signal				
Average	5.80	0.56		
St. Dev.	0.56	0.51		
Min	4.41	0.00		
Max	8.28	2.87		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Acid Vapor	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Shock & Vibration Group**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms: -----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms-----Unstable
 - f. $>+2000$ mOhms: -----Open Failure

SEAF-50-05.0-L-10-2-A-K-TR/ SEAM-50-02.0-L-10-2-A-K-TR

LLCR Measurement Summaries by Pin Type				
Date	5/22/2014	6/2/2014		
Room Temp (Deg C)	21	22		
Rel Humidity (%)	44	44		
Technician	Troy Cook	Troy Cook		
mOhm values	Actual Initial	Delta Shock-Vib	Delta	Delta
Pin Type 1: Signal				
Average	5.69	0.40		
St. Dev.	0.57	0.48		
Min	4.58	0.00		
Max	9.50	3.39		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Shock-Vib	192	0	0	0	0	0

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

SEAF-40-06.5-S-14-2-A-K/SEAM-40-03.5-S-14-2-A-K

LLCR Measurement Summaries by Pin Type				
Date	9/23/2015	9/30/2015		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	45	54		
Technician	Tony Wagoner	Tony Wagoner		
mOhm values	Actual	Delta	Delta	Delta
	Initial	Shock-Vib		
Pin Type 1: Signal				
Average	5.72	0.11		
St. Dev.	0.30	0.13		
Min	5.05	0.00		
Max	6.92	1.15		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
Shock-Vib	192	0	0	0	0	0

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

DATA SUMMARIES Continued**LLCR Extended Life Group**

- 5). A total of 192 points were measured.
- 6). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 7). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 8). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:-----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:-----Marginal
 - e. $+50.1$ to $+2000$ mOhms-----Unstable
 - f. $> +2000$ mOhms:-----Open Failure

250 cycles

LLCR Measurement Summaries by Pin Type				
	5/15/2014	5/15/2014	6/3/2014	6/16/2014
Date	5/15/2014	5/15/2014	6/3/2014	6/16/2014
Room Temp (Deg C)	22	22	22	24
Rel Humidity (%)	56	56	52	51
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	Actual Initial	Delta 250 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	5.90	0.70	0.66	0.81
St. Dev.	0.58	0.52	0.47	0.70
Min	4.67	0.00	0.01	0.00
Max	7.73	2.53	2.26	3.83
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
250 Cycles	192	0	0	0	0	0
Therm Shck	192	0	0	0	0	0
Humidity	192	0	0	0	0	0

DATA SUMMARIES Continued**500 cycles**

LLCR Measurement Summaries by Pin Type				
	5/15/2014	5/20/2014	6/3/2014	6/16/2014
Date	5/15/2014	5/20/2014	6/3/2014	6/16/2014
Room Temp (Deg C)	22	23	22	24
Rel Humidity (%)	56	55	52	51
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	Actual Initial	Delta 500 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	5.61	0.59	0.67	0.94
St. Dev.	0.58	0.50	0.57	0.94
Min	4.67	0.00	0.01	0.03
Max	7.13	2.12	2.58	4.58
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
mOhms	Stable	Minor	Acceptable	Marginal	Unstable	Open
	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
500 Cycles	192	0	0	0	0	0
Therm Shck	192	0	0	0	0	0
Humidity	192	0	0	0	0	0

DATA SUMMARIES Continued**1000 cycles**

LLCR Measurement Summaries by Pin Type				
	5/16/2014	5/20/2014	6/3/2014	6/16/2014
Date	5/16/2014	5/20/2014	6/3/2014	6/16/2014
Room Temp (Deg C)	22	23	22	24
Rel Humidity (%)	56	55	52	51
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	Actual Initial	Delta 1000 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	5.77	0.58	0.75	0.95
St. Dev.	0.57	0.47	0.66	0.99
Min	4.82	0.00	0.00	0.02
Max	7.35	2.51	2.78	5.64
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
mOhms	Stable	Minor	Acceptable	Marginal	Unstable	Open
	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
1000 Cycles	192	0	0	0	0	0
Therm Shck	192	0	0	0	0	0
Humidity	190	2	0	0	0	0

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** HZ-TCT-01**Description:** Normal force analyzer**Manufacturer:** Mecmesin Multitester**Model:** Mecmesin Multitester 2.5-i**Serial #:** 08-1049-04**Accuracy:** Last Cal: 4/26/2014, Next Cal: 4/25/2015**Equipment #:** HZ-OV-01**Description:** Oven**Manufacturer:** Huida**Model:** CS101-1E**Serial #:** CS101-1E-B**Accuracy:** Last Cal: 12/13/2013, Next Cal: 12/12/2014**Equipment #:** HZ-THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** SM-8-8200**Serial #:** 38846**Accuracy:** Last Cal: 2/28/2014, Next Cal: 2/27/2015**Equipment #:** HZ-HPM-01**Description:** NA9636H**Manufacturer:** Ainuo**Model:** 6031A**Serial #:** 089601091**Accuracy:** Last Cal: 3/7/2014, Next Cal: 3/6/2015**Equipment #:** HZ-MO-05**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 1285188**Accuracy:** Last Cal: 11/15/2013, Next Cal: 11/14/2014**Equipment #:** HZ-TSC-01**Description:** Vertical Thermal Shock Chamber**Manufacturer:** Cincinnatti Sub Zero**Model:** VTS-3-6-6-SC/AC**Serial #:** 10-VT14994**Accuracy:** See Manual

... Last Cal: 06/28/2014, Next Cal: 06/27/2015

EQUIPMENT AND CALIBRATION SCHEDULES Continued**Equipment #:** MO-04**Description:** Multimeter /Data Acquisition System**Manufacturer:** Keithley**Model:** 2700**Serial #:** 0798688**Accuracy:** See Manual

... Last Cal: 04/30/2014, Next Cal: 04/30/2015

Equipment #: HZ-MO-01**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 2700**Serial #:** 1199807**Accuracy:** Last Cal: 04/28/2014, Next Cal: 04/28/2015**Equipment #:** HZ-PS-01**Description:** Power Supply**Manufacturer:** Agilent**Model:** 6031A**Serial #:** MY41000982**Accuracy:** Last Cal: 04/28/2014, Next Cal: 04/28/2015**Equipment #:** SVC-01**Description:** Shock & Vibration Table**Manufacturer:** Data Physics**Model:** LE-DSA-10-20K**Serial #:** 10037**Accuracy:** See Manual

... Last Cal: 11/31/2013, Next Cal: 11/31/2014

Equipment #: ACLM-01**Description:** Accelerometer**Manufacturer:** PCB Piezotronics**Model:** 352C03**Serial #:** 115819**Accuracy:** See Manual

... Last Cal: 07/09/2014, Next Cal: 07/09/2015

Equipment #: ED-03**Description:** Event Detector**Manufacturer:** Analysis Tech**Model:** 32EHD**Serial #:** 1100604**Accuracy:** See Manual

... Last Cal: 06/04/2014, Next Cal: 06/04/2015